

PCTEST

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HEARING AID COMPATIBILITY

Applicant Name:

Samsung Electronics Co., Ltd. 129, Samsung-ro, Maetan dong, Yeongtong-gu, Suwon-si Gyeonggi-do 16677, Korea Date of Testing: 06/08/2020 - 06/09/2020 Test Site/Location: PCTEST, Columbia, MD, USA Test Report Serial No.: 1M2004170066-17.A3L Date of Issue: 06/26/2020

FCC ID:

A3LSMN986W

APPLICANT:

SAMSUNG ELECTRONICS CO., LTD.

Scope of Test: Application Type: FCC Rule Part(s): HAC Standard:

DUT Type: Model: Test Device Serial No.: RF Emissions Testing Certification CFR §20.19(b) ANSI C63.19-2011 285076 D01 HAC Guidance v05 285076 D02 T-Coil testing for CMRS IP v03 Portable Handset SM-N986W *Pre-Production Sample* [S/N: 1280M]

C63.19-2011 HAC Category:

M3 (RF EMISSIONS CATEGORY)

This wireless portable device has been shown to be hearing-aid compatible under the above rated category, specified in ANSI/IEEE Std. C63.19-2011 and has been tested in accordance with the specified measurement procedures. Hearing-Aid Compatibility is based on the assumption that all production units will be designed electrically identical to the device tested in this report. Test results reported herein relate only to the item(s) tested. North America bands only.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

Randy Ortanez President



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1. INTRODUCTION

On July 10, 2003, the Federal Communications Commission (FCC) adopted new rules requiring wireless manufacturers and service providers to provide digital wireless phones that are compatible with hearing aids. The FCC has modified the exemption for wireless phones under the Hearing Aid Compatibility Act of 1998 (HAC Act) in WT Docket 01-309 RM-8658¹ to extend the benefits of wireless telecommunications to individuals with hearing disabilities. These benefits encompass business, social and emergency communications, which increase the value of the wireless network for everyone. An estimated more than 10% of the population in the United States show signs of hearing impairment and of that fraction, almost 80% use hearing aids. Approximately 500 million people worldwide suffer from hearing loss.

Compatibility Tests Involved:

The standard calls for wireless communications devices to be measured for:

- RF Electric-field emissions
- T-coil mode, magnetic-signal strength in the audio band
- T-coil mode, magnetic-signal frequency response through the audio band
- T-coil mode, magnetic-signal and noise articulation index

The hearing aid must be measured for:

- RF immunity in microphone mode
- RF immunity in T-coil mode

In the following tests and results, this report includes the evaluation for a wireless communications device.



Figure 1-1 Hearing Aid *in-vitu*

¹ FCC Rule & Order, WT Docket 01-309 RM-8658

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2. DUT DESCRIPTION



FCC ID: Manufacturer:

Serial Number:

DUT Type:

Antenna Configurations:

Model:

A3LSMN986W Samsung Electronics Co., Ltd. 129, Samsung-ro, Maetan dong, Yeongtong-gu, Suwon-si Gyeonggi-do 16677, Korea SM-N986W 1280M Internal Antenna Portable Handset

I. Power Reduction for WIFI

This device uses an independent fixed level power reduction mechanism for all WIFI operations during voice or VoIP held to ear scenarios. Reduced powers were used to evaluate for low-power exemption in Section 9.II for WIFI. Detailed descriptions of the power reduction mechanism are included in the operational description.

II. LTE Band Selection

This device supports the following pairs of LTE bands with similar frequencies: LTE B4 & B66 and LTE B38 & B41. These pairs of LTE bands have the same target powers and share the same transmission paths. Since the supported frequency spans for the smaller LTE bands are completely covered by the larger LTE bands, only the larger LTE bands (LTE B66 & B41) were evaluated for hearing-aid compliance. LTE B2 is an LTE anchor band for dual connectivity (EN-DC) scenarios between LTE and NR so it was additionally evaluated as an independent LTE band.

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Air-Interface	Band (MHz)	Type Transport	HAC Tested	Simultaneous But Not Tested	Name of Voice Service
CDMA	835	VO	Yes	Yes: WIFI or BT	CMRS Voice
CDMA	EvDO	VD	No ¹	Yes: WIFI or BT	Google Duo
	850	vo	Yes	Yes: WIFI or BT	CMRS Voice
GSM	1900	VO	res	res. WIFI OF BI	CIVIKS VOICE
	GPRS/EDGE	VD	No ¹	Yes: WIFI or BT	Google Duo
	850				
UMTS	1700	VD	No ¹	Yes: WIFI or BT	CMRS Voice
010113	1900				
	HSPA	VD	No ¹	Yes: WIFI or BT	Google Duo
	680 (B71)		No ^{1 2}		
	700 (B12)				
	780 (B13)				
	850 (B5)				
LTE (FDD)	1700 (B4)	VD		Yes: WIFI or BT	VoLTE, Google Duo
	1700 (B66)	VD	No ¹	Tes. WIT OF BI	VOLIE, GOOgle Duo
	1900 (B2)				
	1900 (B25)				
	2300 (B30)				
	2500 (B7)				
LTE (TDD)	2600 (B38)	VD	Yes	Yes: WIFI or BT	VoLTE, Google Duo
	2600 (B41)	VD	105	Tes. WIT OF BT	VOLIE, GOOgle Duo
NR (FDD)	680 (n71)	VD	No ^{1 2}	Yes: WIFI or BT	Google Duo
	1700 (n66)		No ¹		
NR (TDD)	2600 (n41)	VD	Yes	Yes: WIFI or BT	Google Duo
	2450				
	5200 (U-NII 1)				
WIFI	5300 (U-NII 2A)	VD	No ¹	Yes: CDMA, GSM, UMTS, LTE, or NR	VoWIFI, Google Duo
	5500 (U-NII 2C)				
	5800 (U-NII 3)				
BT	2450	DT	No	Yes: CDMA, GSM, UMTS, LTE, or NR	N/A
•	y ta - Not intended for /or IP Voice over Dat		2. LTE B71 and	r MIF and low-power exemption. NR n71, while outside the scope of ANSI C63.19 ted according to the existing HAC procedures w	•

Table 2-1 A3LSMN986W HAC Air Interfaces

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ANSI/IEEE C63.19 PERFORMANCE CATEGORIES 3.

I. RF EMISSIONS

The ANSI Standard presents performance requirements for acceptable interoperability of hearing aids with wireless communications devices. When these parameters are met, a hearing aid operates acceptably in close proximity to a wireless communications device.

Category	Telephone RF Parameters				
Near field Category	E-field emissions CW dB(V/m)				
	f < 960 MHz				
M1	50 to 55				
M2	45 to 50				
M3	40 to 45				
M4	< 40				
	f > 960 MHz				
M1	40 to 45				
M2	35 to 40				
M3	30 to 35				
M4	< 30				
Table 3-1 WD near-field categories as defined in ANSI C63.19-2011					

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4. SYSTEM SPECIFICATIONS

EF3DV3 E-Field Probe Description

Construction:	One dipole parallel, two dipoles normal to probe axis
Calibration:	Built-in shielding against static charges In air from 30 MHz to 6.0 GHz (absolute accuracy ±5.1%, k=2)
Frequency:	30 MHz to > 6 GHz;
	Linearity: ± 0.2 dB (30 MHz to 6 GHz)
Directivity	± 0.2 dB in air (rotation around probe axis)
	± 0.4 dB in air (rotation normal to probe axis)
Dynamic Range	2 V/m to > 1000 V/m
	(M3 or better device readings fall well below diode
	compression point)
Linearity:	± 0.2 dB
Dimensions	Overall length: 337 mm (Tip: 20 mm)
	Tip diameter: 4.0 mm (Body: 12 mm)
	Distance from probe tip to dipole centers: 1.5 mm

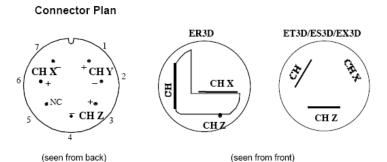


Figure 4-1 E-field Free-space Probe

Probe Tip Description

HAC field measurements take place in the close near field with high gradients. Increasing the measuring distance from the source will generally decrease the measured field values (in case of the validation dipole approx. 10% per mm).

The electric field probes have an irregular internal geometry because it is physically not possible to have the 3 orthogonal sensors situated with the same center. The effect of the different sensor centers is accounted for in the HAC uncertainty budget ("sensor displacement").



The antistatic shielding inside the probe is connected to the probe connector case.

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Instrumentation Chain

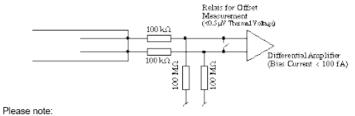
Equation 1 Conversion of Connector Voltage u_i to E-Field E_i

$$E_i = \sqrt{\frac{u_i + (u_i^2 \cdot CF)/(DCP)}{Norm_i \cdot ConvF}}$$

whereby

Ei:	electric field in V/m
Uj.	voltage of channel i at the connector in μV
Norm	sensitivity of channel i in µV/(V/m) ²
ConvF:	enhancement factor in liquid (ConvF=1 for Air)
DCP:	diode compression point in µV
CF:	signal crest factor (peak power/average power)

Conditions of Calibration



a lower input impedance of the amplifier will result in different sensitivity factors Norm, and DCP

larger bias currents will cause higher offset

Probe Response to Frequency

The E-field sensors have inherently a very flat frequency response. They are calibrated with a number of frequencies resulting in a common calibration factor, with the frequency behavior documented in the calibration certificate (See also below).

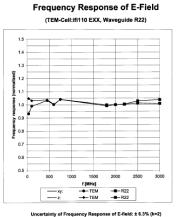


Figure 4-2 E-Field Probe Frequency Response

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SPEAG Robotic System

E-field measurements are performed using the DASY5 automated dosimetric assessment system. The DASY5 is made by Schmid & Partner Engineering AG (SPEAG) in Zurich. Switzerland and consists of high precision robotics system (Staubli), robot controller, Intel CORE i7 computer, near-field probe, probe alignment sensor, and the HAC phantom. The robot is a six-axis industrial robot performing precise movements to position the probe to the location (points) of maximum electromagnetic field (EMF).



Figure 4-3 SPEAG Robotic System

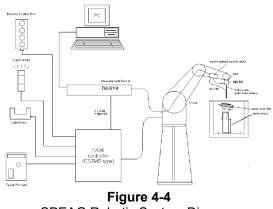
System Hardware

A cell controller system contains the power supply, robot controller, teach pendant (Joystick), and a remote control used to drive the robot motors. The PC consists of the computer with operating system and RF Measurement Software DASY5 v52.8 (with HAC Extension), A/D interface card, monitor, mouse, and keyboard. The Staubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE) circuit that performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.

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System Electronics

The DAE consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.



SPEAG Robotic System Diagram

DASY5 Instrumentation Chain

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics. If the exciting field is pulsed, the crest factor of the signal must be known to correctly compensate for peak power. The formula for each channel can be given as:

$$V_i = U_i + U_i^2 \cdot \frac{cf}{dcp_i}$$

with	V_i	= compensated signal of channel i	(i = x, y, z)
	U_i	= input signal of channel i	(i = x, y, z)
	cf	= crest factor of exciting field	(DASY parameter)
	dcp_i	= diode compression point	(DASY parameter)

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From the compensated input signals the primary field data for each channel can be evaluated:

$$E - field probes : \qquad E_i = \sqrt{\frac{V_i}{Norm_i \cdot ConvF}}$$

with
$$V_i$$
 = compensated signal of channel i (i = x, y, z)
 $Norm_i$ = sensor sensitivity of channel i (i = x, y, z)
 $\mu V/(V/m)^2$ for E-field Probes
 $ConvF$ = sensitivity enhancement in solution
 E_i = electric field strength of channel i in V/m

The RSS value of the field components gives the total field strength (Hermitian magnitude):

$$E_{tot} = \sqrt{E_x^2 + E_y^2 + E_z^2}$$

The primary field data are used to calculate the derived field units.

The measurement/integration time per point, as specified by the system manufacturer is >500ms.

The signal response time is evaluated as the time required by the system to reach 90% of the expected final value after an on/off switch of the power source with an integration time of 500ms and a probe response time of <5 ms. In the current implementation, DASY5 waits longer than 100ms after having reached the grid point before starting a measurement, i.e., the response time uncertainty is negligible.

If the device under test does not emit a CW signal, the integration time applied to measure the electric field at a specific point may introduce additional uncertainties due to the discretization. The tolerances for the different systems had the worst-case of 2.6%.

Environmental Conditions

Environmental conditions such as temperature and relative humidity are monitored to ensure there are no impacts on system specifications. Proper voltage and power line frequency conditions are maintained with three phase power sources. Environmental noise and reflections are monitored through system checks.

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5. TEST PROCEDURE

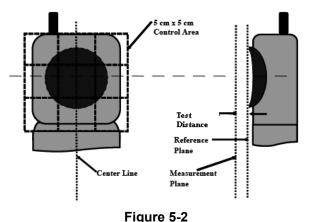
I. RF EMISSIONS

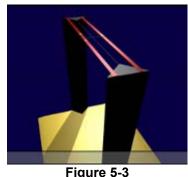
Test Instructions Confirm proper operation of ≻ probes and instrumentation Position WD \succ **Configure WD TX operation** ≻ Per 5.5.1.2 (a-c) Initialize field probe ⋟ Scan Area ≻ Per 5.5.1.2 (d-f) Identify exclusion area. \geq \geq Rescan or reanalyze open area to determine maximum Indirect method: Add the MIF \geq to the maximum steady state rms field strength and record **RF** Audio Interference Level, in dB(V/m) Per 5.5.1.2 (g-h) & 5.5.1.3 Identify and record the ≻ category Per 5.5.1.2 (i-j)

Figure 5-1 RF Emissions Flow Chart

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Test Setup





HAC Phantom

E-Field Emissions Test Setup Diagram (See Test Photographs for actual WD scan grid overlay)

RF Emissions Test Procedure:

The following illustrate a typical RF emissions test scan over a wireless communications device:

- 1. Proper operation of the field probe, probe measurement system, other instrumentation, and the positioning system was confirmed.
- 2. WD is positioned in its intended test position, acoustic output point of the device perpendicular to the field probe.
- 3. The WD operation for maximum rated RF output power was configured and confirmed with the base station simulator, at the test channel and other normal operating parameters as intended for the test. The battery was ensured to be fully charged before each test.
- 4. The center sub-grid was centered over the center of the acoustic output (also audio band magnetic output, if applicable). The WD audio output was positioned tangent (as physically possible) to the measurement plane.
- 5. A surface calibration was performed before each setup change to ensure repeatable spacing and proper maintenance of the measurement plane using the HAC Phantom.
- 6. The measurement system measured the field strength at the reference location.
- 7. Measurements at 2mm or 5mm increments in the 5 x 5 cm region were performed at a distance 15 mm from the center point of the probe measurement element to the WD. Of the 9 subgrids (see Figure 5-2), 3 contiguous subgrids may be excluded from the measurement in order to account for localized areas of higher field intensities. The center subgrid containing the acoustic output or audio band magnetic output may not excluded. A 360° rotation about the azimuth axis at the maximum interpolated position was measured. For the worst-case condition, the peak reading from this rotation was used in re-evaluating the HAC category.
- 8. The system performed a drift evaluation by measuring the field at the reference location. If the power drift deviated by more than 5%, the HAC test and drift measurements were repeated.

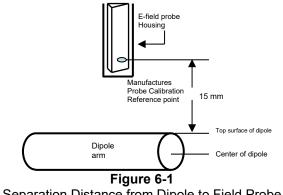
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6. SYSTEM CHECK

I. System Check Parameters

The input signal was an un-modulated continuous wave. The following points were taken into consideration in performing this check:

- Average Input Power P = 100mW RMS (20dBm RMS) after adjustment for return loss
- The test fixture must meet the 2 wavelength separation criterion
- The proper measurement of the 15 mm probe to dipole separation, which is measured from top surface of the dipole to the calibration reference point of the sensor, defined by the probe manufacturer is shown in the following diagram:



Separation Distance from Dipole to Field Probe

RF power was recorded using both an average reading meter and a peak reading meter. Readings of the probe are provided by the measurement system.

To assure proper operation of the near-field measurement probe the input power to the dipole shall be commensurate with the full rated output power of the wireless device [e.g. - for a cellular phone wireless device the average peak antenna input power will be on the order of 100mW (20dBm) RMS] after adjustment for any mismatch.

II. Validation Procedure

A dipole antenna meeting the requirements given in C63.19 was placed in the position normally occupied by the WD.

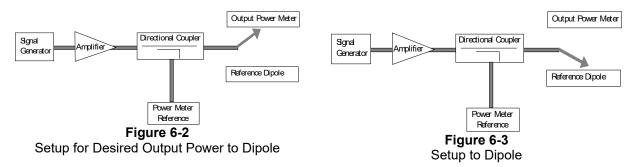
The length of the dipole was scanned, and the average peak value was recorded.

Measurement of CW

Using the near-field measurement system, scan the antenna over the radiating dipole and record the greatest field reading observed. Due to the nature of E-fields about free-space dipoles, the two E-field peaks measured over the dipole are averaged to compensate for non-parallelity of the setup (see manufacturer method on dipole calibration certificates, page 2). Field strength measurements shall be made only when the probe is stationary.

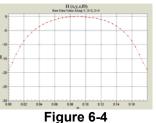
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RF power was recorded using both an average and a peak power reading meter.



Using this setup configuration, the signal generator was adjusted for the desired output power (100mW) at a specified frequency. The reference power from the coupled port of the directional coupler is recorded. Next, the output cable is connected to the reference dipole, as shown in Figure 6-3.

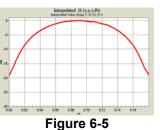
The input signal level was adjusted until the reference power from the coupled port of the directional coupler was the same as previously recorded, to compensate for the impedance mismatch between the output cable and the reference dipole. To assure proper operation of the near-field measurement probe the input power to the reference dipole was verified to the full rated output power of the wireless device. The dipole was secured in a holder in a manner to meet the 20 dB reflection. The near-field measurement probe was positioned over the dipole. The antenna was scanned over the appropriate sized area to cover the dipole from end to end. SPEAG uses 2D interpolation algorithms between the measured points. Please see below two dimensional plots showing that the interpolated values interpolate smoothly between 5mm steps for a free-space RF dipole:



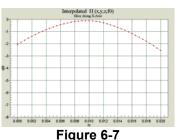
2-D Raw Data from scan along dipole axis



2-D Raw Data from scan along transverse axis



2-D Interpolated points from scan along dipole axis



2-D Interpolated points from scan along transverse axis

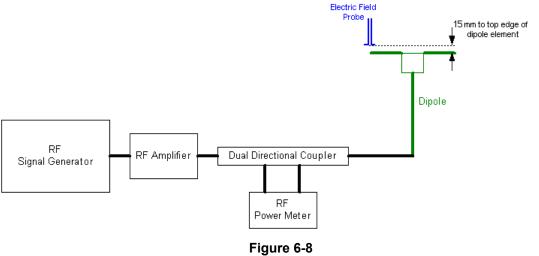
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III. System Check Results

Validation Results

Date	Frequency (MHz)	Probe S/N	DAE S/N	Dipole S/N	Input Power (dBm)	E-field Result (V/m)	Target Field (V/m)	% Deviation
	835			1003	20.0	105.7	105.2	0.4%
6/8/2020	1880	4035	665	1137	20.0	89.6	87.8	2.1%
	2600			1012	20.0	87.5	85.2	2.6%



System Check Setup

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7. MODULATION INTERFERENCE FACTOR

I. Measuring Modulation Interference Factors

For any specific fixed and repeatable modulated signal, a modulation interference factor (MIF, expressed in dB) may be determined that relates its interference potential to its steady-state RMS signal level or average power level. This factor is a function only of the audio-frequency amplitude modulation characteristics of the signal and is the same for field-strength and conducted power measurements. The MIF is valid only for a specific repeatable audio-frequency amplitude modulation characteristic; any change in modulation characteristic requires determination and application of a new MIF.

The MIF may be determined using a radiated RF field or a conducted RF signal:

- a. Using RF illumination or conducted coupling, apply the specific modulated signal in question to the measurement system at a level within its confirmed operating dynamic range.
- b. Measure the steady-state RMS level at the output of the fast probe or sensor.
- c. Measure the steady-state average level at the weighting output.
- d. Without changing the square-law detector or weighting system, and using RF illumination or conducted coupling, substitute for the specific modulated signal a 1 kHz, 80% amplitude modulated carrier at the same frequency and adjust its strength until the level at the weighting output equals the step c) measurement.
- e. Without changing the carrier level from step d), remove the 1 kHz modulation and again measure the steady-state RMS level indicated at the output of the fast probe or sensor.
- f. The MIF for the specific modulation characteristic is provided by the ratio of the step e) measurement to the step b) measurement, expressed in dB (20 × log[(step e)/(step b)]).

The following procedure was used to measure the MIF using the SPEAG Audio Interference Analyzer (AIA), Type No: SE UMS 170 CB, Serial No.: 1010:

- 1. The device was placed into a simulated call using a base station simulator or set to transmit using test software for a given mode.
- 2. The device was then set to continuously transmit at maximum power.
- 3. Using a coupler if needed, the device output signal was connected to the RF In port of the AIA, which was connected to a desktop computer. Alternatively, a radiated RF signal may be used with the AIA's built-in antenna.
- 4. The MIF measurement procedure in the DASY software was run, and the resulting MIF value was recorded.
- 5. Steps 1-4 were repeated for all CMRS air interfaces, frequency bands, and modulations.

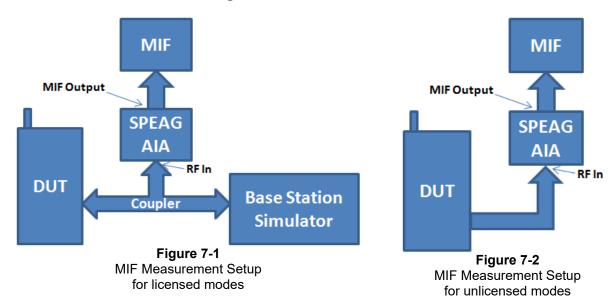
The modulation interference factors obtained were applied to readings taken of the actual wireless device in order to obtain an accurate audio interference level reading using the formula:

Audio Interference Level [dB(V/m)] = 20 * log[Raw Field Value (V/m)] + MIF (dB)

Because the MIF value is output power independent, MIF values for a given mode should be constant across all devices; however, per C63.19-2011 §D.7, MIF values should be measured for each device being evaluated. The voice modes for this device have been investigated in this section of the report.

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II. MIF Measurement Block Diagrams



III. Measured Modulation Interference Factors:

Table 7-1 CDMA Modulation Interference Factors ¹								
	ode		Cell					
IVIC	Jue	1013	384	777				
	RC1/SO3	3.03	3.08	3.08				
CDMA	RC3/SO3	-19.66	-19.76	-19.85				
	EvDO	-19.01	-19.16	-19.37				

Table 7-2 GSM Modulation Interference Factors¹ **GSM850** GSM1900 Mode 128 190 251 512 661 810 3.54 3.55 3.54 3.55 3.55 Voice 3 55 GSM EDGE 4.06 4.09 4.03 3.72 3.72 3.71

Table 7-3 UMTS Modulation Interference Factors¹

Mode			UMTS V		UMTS IV			UMTS II		
		4132	4183	4233	1312	1412	1513	9262	9400	9538
	12.2 kbps RMC	-24.55	-23.83	-22.15	-24.07	-22.05	-22.73	-24.00	-23.81	-24.00
UMTS	12.2 kbps AMR	-13.46	-13.73	-13.49	-13.72	-13.57	-13.44	-13.50	-14.30	-13.59
	HSUPA Subtest1	-23.52	-23.27	-22.41	-22.45	-22.66	-20.93	-23.12	-23.35	-23.52

¹ Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

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LTE Band	Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation	RB Size	RB Offset	MIF [dB]
71	680.5	133297	20	16QAM	1	0	-9.87
12	707.5	23095	10	16QAM	1	0	-10.19
13	782.0	23230	10	16QAM	1	0	-9.95
5	836.5	20525	10	16QAM	1	0	-10.70
66	1745.0	132322	20	16QAM	1	0	-9.86
2	1880.0	18900	20	16QAM	1	0	-10.13
25	1882.5	26365	20	16QAM	1	0	-10.20
30	2310.0	27710	10	16QAM	1	0	-10.69
7	2535.0	21100	20	16QAM	1	0	-9.79
7	2535.0	21100	20	64QAM	1	0	-9.53
7	2535.0	21100	20	256QAM	1	0	-9.54
7	2535.0	21100	20	QPSK	1	0	-15.13
7	2535.0	21100	20	64QAM	1	50	-9.35
7	2535.0	21100	20	64QAM	1	99	-9.35
7	2535.0	21100	20	64QAM	50	0	-15.79
7	2535.0	21100	20	64QAM	100	0	-16.65
7	2535.0	21100	15	64QAM	1	74	-9.42
7	2535.0	21100	10	64QAM	1	49	-9.58
7	2535.0	21100	5	64QAM	1	24	-9.71
7	2510.0	20850	20	64QAM	1	99	-9.86
7	21350.0	21350	20	64QAM	1	99	-9.86

 Table 7-4

 LTE FDD Modulation Interference Factors^{1,2}

 Table 7-5

 LTE TDD B41 Power Class 3 Modulation Interference Factors^{1,3}

LTE Band	Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation RB Size		RB Offset	MIF [dB]
41	2593.0	40620	20	16QAM	1	0	3.65
41	2593.0	40620	20	QPSK	1	0	3.57
41	2593.0	40620	20	64QAM	1	0	3.45
41	2593.0	40620	20	256QAM	1	0	3.45
41	2593.0	40620	20	16QAM	1	50	3.48
41	2593.0	40620	20	16QAM	1	99	3.46
41	2593.0	40620	20	16QAM	50	0	3.42
41	2593.0	40620	20	16QAM	100	0	3.41
41	2593.0	40620	15	16QAM	1	0	3.70
41	2593.0	40620	10	16QAM	1	0	3.70
41	2593.0	40620	5	16QAM	1	0	3.59
41	2506.0	39750	15	16QAM	1	0	3.65
41	2549.5	40185	15	16QAM	1	0	3.50
41	2636.5	41055	15	16QAM	1	0	3.71
41	2680.0	41490	15	16QAM	1	0	3.59

¹ Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

² Note: All LTE FDD bands were found to have substantially similar MIF values given similar RB, BW, and modulation configurations.

³ Note: LTE TDD MIFs were taken using UL-DL Configuration 5. More information about the chosen UL-DL Configuration can be found in Section 10.

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	11		modulat			401013		
NR Band	Frequency [MHz]	Channel	Bandwidth [MHz]	Waveform	Modulation	RB Size	RB Offset	MIF [dB]
n71	680.5	136100	20	DFT-s-OFDM	16QAM	1	1	-10.60
n66	1745.0	349000	20	DFT-s-OFDM	16QAM	1	1	-10.06
n66	1745.0	349000	20	DFT-s-OFDM	π/2-BPSK	1	1	-17.59
n66	1745.0	349000	20	DFT-s-OFDM	QPSK	1	1	-17.58
n66	1745.0	349000	20	DFT-s-OFDM	64QAM	1	1	-11.03
n66	1745.0	349000	20	DFT-s-OFDM	256QAM	1	1	-10.82
n66	1745.0	349000	20	CP-OFDM	QPSK	1	1	-13.37
n66	1745.0	349000	20	CP-OFDM	16QAM	1	1	-12.40
n66	1745.0	349000	20	CP-OFDM	64QAM	1	1	-11.03
n66	1745.0	349000	20	CP-OFDM	256QAM	1	1	-10.90
n66	1745.0	349000	20	DFT-s-OFDM	16QAM	1	53	-10.88
n66	1745.0	349000	20	DFT-s-OFDM	16QAM	1	104	-10.88
n66	1745.0	349000	20	DFT-s-OFDM	16QAM	50	0	-17.55
n66	1745.0	349000	20	DFT-s-OFDM	16QAM	100	0	-20.09
n66	1745.0	349000	15	DFT-s-OFDM	16QAM	1	1	-10.48
n66	1745.0	349000	10	DFT-s-OFDM	16QAM	1	1	-10.67
n66	1745.0	349000	5	DFT-s-OFDM	16QAM	1	1	-10.69
n66	1720.0	344000	20	DFT-s-OFDM	16QAM	1	1	-10.80
n66	1770.0	354000	20	DFT-s-OFDM	16QAM	1	1	-10.63

Table 7-6 NR FDD Modulation Interference Factors^{1,2}

	1	NR TDD	Modula	tion Inter	ference	Factors	1	
NR Band	Frequency [MHz]	Channel	Bandwidth [MHz]	Waveform	Modulation	RB Size	RB Offset	MIF [dB]
n41	2593.0	518598	100	DFT-s-OFDM	π/2-BPSK	1	1	1.41
n41	2593.0	518598	100	DFT-s-OFDM	QPSK	1	1	1.36
n41	2593.0	518598	100	DFT-s-OFDM	16QAM	1	1	1.35
n41	2593.0	518598	100	DFT-s-OFDM	64QAM	1	1	1.25
n41	2593.0	518598	100	DFT-s-OFDM	256QAM	1	1	1.18
n41	2593.0	518598	100	CP-OFDM	QPSK	1	1	1.18
n41	2593.0	518598	100	CP-OFDM	16QAM	1	1	1.28
n41	2593.0	518598	100	CP-OFDM	64QAM	1	1	1.21
n41	2593.0	518598	100	CP-OFDM	256QAM	1	1	1.06
n41	2593.0	518598	100	DFT-s-OFDM	π/2-BPSK	1	137	1.41
n41	2593.0	518598	100	DFT-s-OFDM	π/2-BPSK	1	271	1.41
n41	2593.0	518598	100	DFT-s-OFDM	π/2-BPSK	135	0	1.43
n41	2593.0	518598	100	DFT-s-OFDM	π/2-BPSK	270	0	1.43
n41	2593.0	518598	90	DFT-s-OFDM	π/2-BPSK	243	0	1.44
n41	2593.0	518598	80	DFT-s-OFDM	π/2-BPSK	216	0	1.44
n41	2593.0	518598	60	DFT-s-OFDM	π/2-BPSK	162	0	1.45
n41	2593.0	518598	50	DFT-s-OFDM	π/2-BPSK	128	0	1.45
n41	2593.0	518598	40	DFT-s-OFDM	π/2-BPSK	100	0	1.47
n41	2593.0	518598	20	DFT-s-OFDM	π/2-BPSK	50	0	1.48
n41	2506.0	501204	20	DFT-s-OFDM	π/2-BPSK	50	0	1.49
n41	2549.5	509898	20	DFT-s-OFDM	π/2-BPSK	50	0	1.45
n41	2636.5	527298	20	DFT-s-OFDM	π/2-BPSK	50	0	1.45
n41	2680.0	535998	20	DFT-s-OFDM	π/2-BPSK	50	0	1.46

Table 7-7 R TDD Modulation Interference Factors

¹ Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

² Note: All NR FDD bands were found to have substantially similar MIF values given similar RB, BW, and modulation configurations.

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Table 7-8								
802.11b (2.4GHz, SISO) Modulation Interference Factors ^{1,2}								
802.11b MIF Measurements [dB]								
	Mode	Data Rate [Mbps]						
		1	2	5.5	11			
	802.11b	-10.26	-9.45	-7.29	-6.29			

Table 7-9 802.11g (2.4GHz, SISO) Modulation Interference Factors^{1,2} 802 11c MIE Moasurements IdBl

	802.11g MIF Measurements [dB]								
Mode	Data Rate [Mbps]								
	6	9	12	18	24	36	48	54	
802.11g	-7.54	-6.78	-6.20	-5.49	-5.06	-4.83	-4.92	-4.97	

Table 7-10

802.11g (2.4GHz, MIMO) Modulation Interference Factors^{1,2}

			802.1 ⁻	1g MIF Mea	asurement	ts [dB]		
Mode Data Rate [Mbps]								
	12	18	24	36	48	72	92	108
802.11g	-7.49	-6.20	-6.15	-5.41	-5.01	-4.76	-4.87	-4.98

Table 7-11
802.11n (2.4GHz, SISO) Modulation Interference Factors ^{1,2}
902.44 m/2.4 CH MIE Maaauwa maata [dB]

	802.11n (2.4GHz) MIF Measurements [dB]							
Mode				MCS	Index			
	0	1	2	3	4	5	6	7
802.11n	-7.44	-6.15	-5.48	-5.08	-4.79	-4.84	-4.93	-4.99

Table 7-12 802.11n (2.4GHz, MIMO) Modulation Interference Factors^{1,2} 902.11n (2.4GHz, MIMO) MIE Moasurements IdBl

802.11h (2.4GHz) MIF Measurements [dB]								
Mode				MCS	Index			
	0	1	2	3	4	5	6	7
802.11n	-7.41	-6.04	-5.44	-5.05	-4.76	-4.76	-4.85	-5.04

Table 7-13

802.11ax (2.4GHz, SU, SISO) Modulation Interference Factors^{1,2}

	20MHz 802.11ax (2.4GHz) MIF Measurements [dB]									
Mode	MCS Index									
	0	1	2	3	4	5	6	7	8	9
802.11ax	-6.93	-5.71	-5.11	-4.82	-4.75	-4.86	-4.96	-5.01	-5.13	-5.27

¹ Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

 $^{2}\,\mbox{Note:}$ WIFI MIF values were found to be independent of the transmit channel.

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	802.11ax (2.4GHz, SU, MIMO) Modulation Interference Factors ^{1,2}									
	20MHz 802.11ax (2.4GHz) MIF Measurements [dB]									
Mode		MCS Index								
0 1 2 3 4 5 6 7 8							9			
802.11ax	-5.69	-4.84	-4.67	-4.83	-5.13	-5.40	-5.51	-5.64	-5.70	-5.81

Table 7-14								
802.11ax (2.4GHz, SU, MIMO) Modulation Interference Factors ^{1,2}							

Table 7-15
802.11ax (2.4GHz, RU, SISO) Modulation Interference Factors ^{1,2}
20MHz 802.11ax (2.4GHz) MIF Measurements [dB]

- - -

Mode		RU Index (MCS Index 4) (GI 1.6us)									
	0	8	37	40	53	54	61				
802.11ax	-8.25	-7.95	-6.89	-6.56	-5.56	-5.27	-4.67				

Table 7-16

802.11ax (2.4GHz, RU, MIMO) Modulation Interference Factors^{1,2}

	•	20MHz 80	2.11ax (2.4	4GHz) MIF	Measurem	nents [dB]		
Mode	RU Index (MCS Index 2) (GI 1.6us)							
	0	8	37	40	53	54	61	
802.11ax	-8.06	-7.76	-6.65	-6.39	-5.56	-5.19	-4.68	

T	ab	le	7.	-1	7

802.11a (5GHz, 20MHz BW, SISO) Modulation Interference Factors^{1,2}

			802.11	1a MIF Mea	asurement	s [dB]		
Mode Data Rate [Mbps]								
	6	9	12	18	24	36	48	54
802.11a	-13.85	-13.39	-12.60	-12.03	-11.95	-12.48	-12.99	-13.22

Table 7-18
802.11a (5GHz, 20MHz BW, MIMO) Modulation Interference Factors ^{1,2}

		802.11a MIF Measurements [dB]										
Mode	Data Rate [Mbps]											
	12	18	24	36	48	72	92	108				
802.11a	-13.61	-13.19	-12.71	-11.75	-11.91	-12.16	-12.84	-12.69				

Table 7-19

802.11n (5GHz, 20MHz BW, SISO) Modulation Interference Factors^{1,2}

	20MHz BW 802.11n (5GHz) MIF Measurements [dB]											
Mode		MCS Index										
	0	1	2	3	4	5	6	7				
802.11n	-13.92	3.92 -12.71 -12.24 -12.00 -12.49 -12.25 -13.17 -13										

¹ Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

² Note: WIFI MIF values were found to be independent of the transmit channel.

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802.11n (5GHz, 20MHz BW, MIMO) Modulation Interference Factors ^{1,2}											
20MHz BW 802.11n (5GHz) MIF Measurements [dB]											
Mode		MCS Index									
	0	1	2	3	4	5	6	7			
802.11n	-13.17	-12.11	-11.60	-11.38	-11.77	-12.29	-12.67	-12.91			

 Table 7-20

 802.11n (5GHz, 20MHz BW, MIMO) Modulation Interference Factors^{1,2}

Table 7-21
802.11ac (5GHz, 20MHz BW, SISO) Modulation Interference Factors ^{1,2}
20MHz BW 802 11ac (5GHz) MIE Measurements [dB]

		MCS Index										
Mode												
	0	1	2	3	4	5	6	7	8			
802.11ac	-14.08	-12.84	-12.02	-11.83	-12.08	-12.61	-13.00	-13.25	-13.64			

Table 7-22

802.11ac (5GHz, 20MHz BW, MIMO) Modulation Interference Factors^{1,2}

	20MHz BW 802.11ac (5GHz) MIF Measurements [dB]											
Mode		MCS Index										
0 1 2 3 4							6	7	8			
802.11ac	-12.10	-12.10 -11.44 -11.55 -12.15 -13.21 -14.18 -14.24 -14.51 -14.96										

Table 7-23

802.11ax (5GHz, 20MHz BW, SU, SISO) Modulation Interference Factors^{1,2}

		20MHz 802.11ax (5GHz) MIF Measurements [dB]										
Mode		MCS Index										
	0	1	2	3	4	5	6	7	8	9	10	11
802.11ax	-13.38	-12.25	-11.83	-11.71	-12.34	-12.77	-12.92	-12.99	-13.67	-14.04	-14.23	-14.31

Table 7-24

802.11ax (5GHz, 20MHz BW, SU, MIMO) Modulation Interference Factors^{1,2}

		20MHz 802.11ax (5GHz) MIF Measurements [dB]										
Mode		MCS Index										
	0	1	2	3	4	5	6	7	8	9	10	11
802.11ax	-11.83	-11.41	-11.80	-12.37	-13.17	-14.07	-14.09	-14.26	-14.46	-14.50	-14.97	-15.44

Table 7-25

802.11ax (5GHz, 20MHz BW, RU, SISO) Modula	tion Interference Factors ^{1,2}
--	--

	20MHz 802.11ax (5GHz) MIF Measurements [dB]											
Mode		RU Index (MCS Index 3) (GI 1.6us)										
	0	8	37	40	53	54	61					
802.11ax	-13.43	-13.29	-13.35	-13.13	-12.47	-12.25	-11.49					

¹ Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

² Note: WIFI MIF values were found to be independent of the transmit channel.

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802 11av (5CHz		II MIMO) Modulation	Interference Factors ^{1,2}
	ZUIVII IZ DVV. NU		

002.1										
20MHz 802.11ax (5GHz) MIF Measurements [dB]										
Mode		RU Index (MCS Index 1) (GI 1.6us)								
	0	8	37	40	53	54	61			
802.11ax	-12.75	-12.84	-12.56	-12.50	-11.44	-11.39	-10.92			

Table 7-27 802.11n (5GHz, 40MHz BW, SISO) Modulation Interference Factors^{1,2}

		40MHz BW 802.11n (5GHz) MIF Measurements [dB]								
Mode		MCS Index								
	0	1	2	3	4	5	6	7		
802.11n	-11.88	-11.09	-11.65	-12.16	-13.54	-14.27	-14.88	-15.33		

Table 7-28

802.11n (5GHz, 40MHz BW, MIMO) Modulation Interference Factors^{1,2}

		40MHz BW 802.11n (5GHz) MIF Measurements [dB]									
Mode		MCS Index									
	0	1	2	3	4	5	6	7			
802.11n	-11.37	-10.76	-11.24	-11.69	-13.29	-14.06	-14.62	-15.16			

Table 7-29
802.11ac (5GHz, 40MHz BW, SISO) Modulation Interference Factors ^{1,2}
40MHz BW 802 11ac (5GHz) MIE Measurements (dB)

		40MHZ BW 602. That (30HZ) MIF Measurements [ub]									
Mode		MCS Index									
	0	1	2	3	4	5	6	7	8	9	
802.11ac	-11.61	-10.82	-11.49	-12.00	-13.40	-14.32	-14.57	-15.10	N/A	-16.34	

Table 7-30

802.11ac (5GHz, 40MHz BW, MIMO) Modulation Interference Factors^{1,2}

	40MHz BW 802.11ac (5GHz) MIF Measurements [dB]									
Mode		MCS Index								
	0	1	2	3	4	5	6	7	8	9
802.11ac	-10.60	-11.68	-12.93	-14.02	-15.19	-16.37	-16.66	-16.67	N/A	-17.06

Table 7-31

802.11ax (5GHz, 40MHz BW, SU, SISO) Modulation Interference Factors^{1,2}

		40MHz 802.11ax (5GHz) MIF Measurements [dB]										
Mode		MCS Index										
	0	1	2	3	4	5	6	7	8	9	10	11
802.11ax	-11.45	-11.08	-11.74	-12.26	-13.20	-13.19	-13.23	-14.60	-14.86	-15.15	-15.31	-15.98

¹ Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

² Note: WIFI MIF values were found to be independent of the transmit channel.

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Table	7-32
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	802.11ax (5GHz, 40MHz BW, SU, MIMO) Modulation Interference Factors ^{1,2}												
40MHz 802.11ax (5GHz) MIF Measurements [dB]													
Mode		MCS Index											
	0	1	2	3	4	5	6	7	8	9	10	11	
802.11ax	-12 84	-13 33	-12 93	-12 05	-11 63	-11 89	-11 64	-10.96	-11 18	-10 42	-16 12	-16 12	

Table 7-33

802.11ax (5GHz, 40MHz BW, RU, SISO) Modulation Interference Factors^{1,2}

			40MHz 8	02.11ax (5	GHz) MIF N	leasurem	ents [dB]			
Mode	RU Index (MCS Index 1) (GI 1.6us)									
	0	17	37	44	53	56	61	62	65	
802.11ax	-15.81	-15.35	-15.15	-14.70	-13.94	-13.42	-12.13	-11.68	-11.01	

Table 7-34

802.11ax (5GHz, 40MHz BW, RU, MIMO) Modulation Interference Factors^{1,2}

			40MHz 8	02.11ax (5	GHz) MIF I	leasurem	ents [dB]						
Mode	Mode RU Index (MCS Index 9) (GI 1.6us)												
	0	17	37	44	53	56	61	62	65				
802.11ax	-10.43	-10.43 -10.85 -11.42 -11.47 -12.47 -12.33 -14.09 -14.08 -15.46											

Table 7-35

802.11ac (5GHz, 80MHz BW, SISO) Modulation Interference Factors^{1,2}

			80MH	Iz BW 802.	11ac (5GH	z) MIF Mea	surement	s [dB]		
Mode	MCS Index									
	0	1	2	3	4	5	6	7	8	9
802.11ac	-11.12	-11.95	-12.87	-14.39	-15.96	-16.66	-16.86	-16.85	-17.15	-17.62

Table 7-36 802 11ac (5GHz, 80MHz BW, MIMO) Modulation Interference Factors^{1,2}

	doz. 1 rad (doznaz, domina bitt, minito) modulation interference radiate
	80MHz BW 802.11ac (5GHz) MIF Measurements [dB]
`	MCS Index

Mode		MCS Index										
	0	0 1 2 3 4 5 6 7 8 9										
802.11ac	-11.94	-14.08	-15.40	-16.22	-16.81	-17.61	-17.54	-17.49	-17.24	-17.44		

Table 7-37

802.11ax (5GHz, 80MHz BW, SU, SISO) Modulation Interference Factors^{1,2}

				80N	1Hz 802.11	ax (5GHz)	MIF Measu	urements [dB]			
Mode		MCS Index										
	0	1	2	3	4	5	6	7	8	9	10	11
802.11ax	-11.05	-12.61	-13.40	-13.98	-15.09	-15.97	-15.96	-16.12	-16.59	-16.77	-16.58	-16.77

¹ Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

² Note: WIFI MIF values were found to be independent of the transmit channel.

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Т	able	7-38
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			· · · · · · · · · · · · · · · · · · ·	80N	1Hz 802.11	ax (5GHz)	MIF Measu	urements [dB]				
Mode		MCS Index											
	0	1	2	3	4	5	6	7	8	9	10	11	
802.11ax	-12.23	-13.98	-14.41	-15.23	-15.78	-16.43	-15.76	-15.89	-16.10	-16.52	-16.53	-16.64	

Table 7-39

802.11ax (5GHz, 80MHz BW, RU, SISO) Modulation Interference Factors^{1,2}

				80MHZ 8	02.11ax (5	GHZ) MIF I	vieasurem	ents [aB]			
Mode	e RU Index (MCS Index 0) (GI 1.6us)										
	0	36	37	52	53	60	61	64	65	66	67
802.11ax	-15.61	-15.37	-15.10	-14.80	-13.88	-13.63	-12.00	-12.00	-10.90	-10.85	-10.87

Table 7-40

802.11ax (5GHz, 80MHz BW, RU, MIMO) Modulation Interference Factors^{1,2}

		80MHz 802.11ax (5GHz) MIF Measurements [dB]										
Mode		RU Index (MCS Index 0) (GI 1.6us)										
	0	36	37	52	53	60	61	64	65	66	67	
802.11ax	-13.30	-13.34	-13.55	-13.56	-12.70	-12.76	-11.30	-11.41	-10.38	-10.30	-11.22	

# Tx		z WIFI Bm]		lz WIFI 3m]	Measured MIF (dB)	
Тх	Ant1	Ant2	Ant1	Ant2	(UB)	
2	x	-	-	x	-5.09	
2	-	x	х	-	-5.09	
2	x	-	x	-	-5.05	
2	-	x	-	x	-5.07	
3	x	x	x	-	-5.49	
3	x	x	-	x	-5.48	
3	x	-	x	x	-5.06	
3	-	x	x	x	-5.07	
4	х	х	x	x	-5.48	

Table 7-41 Simultaneous 2.4GHz and 5GHz WIFI Modulation Interference Factors^{1,2,3}

¹ Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

² Note: WLAN MIF values were found to be independent of the transmit channel.

³ Note: The configuration for each scenario (e.g. bandwidth, data rate, etc.) was determined using the worst-case configuration from SISO and MIMO MIF measurements.

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8. RF CONDUCTED POWER MEASUREMENTS

I. Procedures Used to Establish RF Signal for HAC Testing

The handset was configured to transmit the required air interface in a shielded chamber. Measurements were taken with a fully charged battery.

II. HAC Measurement Conditions

Output Power Verification

Maximum output power is verified on the High, Middle and Low channels for all applicable air interfaces for which full testing scans are required. Modes which are exempted from full testing according to Section 9 of this report have only their conducted power targets listed below, not measured values. See Table 8-1 for air interface specific settings of transmit power parameters. See Table 9-1 for more information regarding which modes required full testing and had conducted power measurements taken.

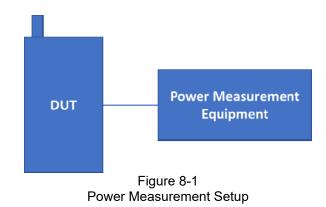
Power Co	Power Control Parameters and Settings by Air Interface									
Air Interface:	Parameter Name:	Parameter Set To:								
CDMA	Power Control Bits	"All Up"								
GSM	PCL	GSM850: "5"; GSM1900: "0"								
UMTS	TPC	"All 1's"								
LTE	TPC	"Max Power"								
NR	PLS	Mfr Specified								
WIFI	PLS	Mfr Specified								

 Table 8-1

 Power Control Parameters and Settings by Air Interface

III. Setup Used to Measure RF Conducted Powers

The general setup for conducted power is shown in Figure 8-1 below. The power measurement equipment could be a base station simulator, signal analyzer, or power meter depending on the applicable air interface.



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IV. CDMA Conducted Powers

Band	Channel	Frequency	SO2 [dBm]	SO2 [dBm]	SO2 [dBm]	SO55 [dBm]	SO55 [dBm]	SO75 [dBm]	SO9 [dBm]	SO9 [dBm]	SO3 [dBm]	SO3 [dBm]	SO3 [dBm]	1x EvDO Rev. A [dBm]
	F-RC	MHz	RC1	RC3	RC4	RC1	RC3	RC11	RC2	RC5	RC1	RC3	RC4	(RETAP)
	1013	824.7	24.74	24.72	24.73	24.74	24.72	24.70	24.70	24.68	24.71	24.70	24.71	24.58
Cellular	384	836.52	24.73	24.73	24.71	24.72	24.73	24.71	24.72	24.69	24.73	24.72	24.73	24.56
	777	848.31	24.49	24.50	24.48	24.50	24.49	24.51	24.48	24.50	24.49	24.50	24.48	24.35

V. GSM Conducted Powers

Band	Channel	GSM [dBm] CS (1 Slot)	EDGE [dBm] 1 Tx Slot	
	128	32.84	27.01	
GSM 850	190	33.14	27.17	
	251	32.67	26.66	
	512	29.82	25.76	
GSM 1900	661	29.56	25.70	
	810	29.87	25.96	

VI. UMTS Target Powers

Table 8-2 UMTS Conducted Power Targets

	Modulated Average (dBm)				
Mode / Band	3GPP	3GPP	3GPP	3GPP	
	WCDMA	HSDPA	HSUPA	DC-HSDPA	
	Maximum	25.8	24.8	24.8	24.8
UMTS Band 5 (850 MHz)	Nominal	24.8	23.8	23.8	23.8
LINATE Dand 4 (17EO MUZ)	Maximum	24.5	23.5	23.5	23.5
UMTS Band 4 (1750 MHz)	Nominal	23.5	22.5	22.5	22.5
UMTS Band 2 (1900 MHz)	Maximum	24.0	23.0	23.0	23.0
	Nominal	23.0	22.0	22.0	22.0

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VII. LTE FDD Target Powers

LTE FDD Conducted Power Targets								
Mode / Band	Modulated Average							
	(dBm)							
LTE B71	Maximum	25.8						
	Nominal	24.8						
LTE B12	Maximum	25.8						
	Nominal	24.8						
	Maximum	25.8						
LTE B13	Nominal	24.8						
	Maximum	25.8						
LTE Band 5 (Cell)	Nominal	24.8						
	Maximum	24.5						
LTE Band 66 (AWS)	Nominal	23.5						
	Maximum	24.5						
LTE Band 4 (AWS)	Nominal	23.5						
	Maximum	24.5						
LTE Band 2 (PCS)	Nominal	23.5						
LTE Dand DE (DCC)	Maximum	24.5						
LTE Band 25 (PCS)	Nominal	23.5						
LTE Dand 20	Maximum	24.0						
LTE Band 30	Nominal	23.0						
LTE Dand 7	Maximum	24.0						
LTE Band 7	Nominal	23.0						

Table 8-3 LTE FDD Conducted Power Targ

VIII. LTE TDD Target Powers

Table 8-4 LTE TDD Conducted Power Targets									
Mode / Band	Modulated Average								
Wode / Balld		(dBm)							
LTE Band 41 (DC2)	Maximum	25.0							
LTE Band 41 (PC3)	Nominal	24.0							
LTC Dand 29	Maximum	25.0							
LTE Band 38	Nominal	24.0							

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IX. NR FDD Target Powers

	DD Conducted Powe	a rargers	
Mode / Band	Mode / Band		
Wode / Balld		(dBm)	
ND Dand n71	Maximum	25.5	
NR Band n71	Nominal	24.5	
	Maximum	24.5	
NR Band n66 (AWS)	Nominal	23.5	

Table 8-5 NR EDD Conducted Power Targets

X. NR TDD Target Powers

a. NR n41

NR n41 (2593.0	MHz) Cor	nducted P	owers – 100	MHz Ban	dwidt					
NR Band n41										
		100 MHz Band		1						
		n	Channel							
Modulation	RB Size	RB Offset	518598 (2592.99 MHz)	MPR Allowed per 3GPP	MPR [dB]					
modulation		NB Oliset	Conducted Power [dBm]	[dB]	[]					
	1	1	24.79		0					
DFT-s-OFDM	1	137	24.89	0	0					
	1	271	24.86		0					
π/2 BPSK	135	0	24.71	0-0.5	0.5					
N/2 DI SIC	135	69	24.84	0	0					
	135	138	24.47	0-0.5	0.5					
	270	0	24.56	0-0.5	0.5					
	1	1	24.98		0					
	1	137	24.85	0	0					
DFT-s-OFDM	1	271	24.62		0					
QPSK	135	0	23.91	0-1	1					
QFOR	135	69	24.63	0	0					
	135	138	23.83	0-1	1					
	270	0	23.92	0-1	1					
DFT-s-OFDM 16QAM	1	1	24.34	0-1	1					
CP-OFDM QPSK	1	1	23.75	0-1.5	1.5					

Table 8 NR n41 (2593.0MHz) Conducted P	•)MHz Bar	ndwidth				
NR Band n	41						
100 MHz Bandwidth							
	Channel						

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INK 1141	(2595.0101		cted Powers		anuwium	
			R Band n41 Hz Bandwidth			
		30 101		nnel		
Modulation	RB Size	RB Offset	508200 (2541 MHz)	528996 (2644.98 MHz)	MPR Allowed per 3GPP	MPR [dB]
			Conducted I	Power [dBm]	[dB]	
	1	1	24.35	25.07		0
	1	123	24.66	24.80	0	0
	1	243	24.64	24.81	1	0
DFT-s-OFDM π/2 BPSK	120	0	24.08	24.24	0-0.5	0.5
N/2 DF SK	120	63	24.56	24.65	0	0
	120	125	24.17	24.29	0-0.5	0.5
	243	0	24.29	24.24	0-0.5	0.5
	1	1	24.30	24.98		0
	1	123	24.58	24.85	0	0
	1	243	24.53	24.77	1	0
DFT-s-OFDM QPSK	120	0	23.42	23.75	0-1	1
	120	63	24.59	24.64	0	0
	120	125	23.54	23.74	0-1	1
	243	0	23.50	23.72	0-1	1
DFT-s-OFDM 16QAM	1	1	23.72	23.61	0-1	1
CP-OFDM QPSK	1	1	23.07	23.65	0-1.5	1.5

Table 8-7 NR n41 (2593.0MHz) Conducted Powers – 90MHz Bandwidth

 Table 8-8

 NR n41 (2593.0MHz) Conducted Powers – 80MHz Bandwidth

	NR Band n41									
			Hz Bandwidth							
			Cha							
Modulation	RB Size	RB Size RB Off	RB Offset	507204 (2536.02 MHz)	529998 (2649.99 MHz)	MPR Allowed per 3GPP	MPR [dB]			
			Conducted I	[dB]						
	1	1	24.47	24.88		0				
	1	109	24.78	24.86	0	0				
DFT-s-OFDM	1	215	24.73	24.81		0				
$\pi/2$ BPSK	108	0	24.21	24.44	0-0.5	0.5				
N/2 DI SK	108	55	24.69	24.76	0	0				
	108	109	24.42	24.45	0-0.5	0.5				
	216	0	24.31	24.28	0-0.5	1				
	1	1	24.34	24.79		0				
	1	109	24.61	24.81	0	0				
	1	215	24.51	24.66	1	0				
DFT-s-OFDM QPSK	108	0	23.58	23.86	0-1	1				
QION	108	55	24.65	24.83	0	0				
	108	109	23.74	23.78	0-1	1				
	216	0	23.67	23.79	0-1	1				
DFT-s-OFDM 16QAM	1	1	23.36	23.52	0-1	1				
CP-OFDM QPSK	1	1	22.98	23.38	0-1.5	1.5				

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	1141 (259	5.01VITIZ) (NR Band n			num		
			60 MHz Band N					
				Channel				
Modulation	RB Size	RB Size	RB Size RB Offset	505200 (2526 MHz)	518598 (2592.99 MHz)	531996 (2659.98 MHz)	MPR Allowed per 3GPP	MPR [dB]
			Cor	[dB]				
	1	1	24.62	24.95	24.84		0	
DFT-s-OFDM	1	81	24.78	25.05	25.04	0	0	
	1	160	24.92	25.12	25.07		0	
π/2 BPSK	81	0	24.25	24.77	24.73	0-0.5	0.5	
M/2 BI SK	81	41	24.74	25.10	25.08	0	0	
	81	81	24.55	24.72	24.69	0-0.5	0.5	
	162	0	24.19	24.83	24.58	0-0.5	0.5	
	1	1	24.64	25.24	25.03		0	
	1	81	24.67	25.22	24.96	0	0	
DFT-s-OFDM	1	160	24.96	25.03	25.11	1	0	
QPSK	81	0	23.65	24.20	24.04	0-1	1	
QION	81	41	24.79	25.15	24.99	0	0	
	81	81	23.88	24.28	24.07	0-1	1	
	162	0	23.69	24.20	23.94	0-1	1	
DFT-s-OFDM 16QAM	1	1	23.75	24.08	23.43	0-1	1	
CP-OFDM QPSK	1	1	23.23	23.69	23.35	0-1.5	1.5	

Table 8-9 NR n41 (2593.0MHz) Conducted Powers – 60MHz Bandwidth

Table 8-10NR n41 (2593.0MHz) Conducted Powers – 50MHz Bandwidth

		*	NR Band n 50 MHz Bandy										
				Channel									
Modulation	RB Size	RB Size	RB Size	RB Size	RB Size	RB Size	RB Size	RB Offset	504204 (2521.02 MHz)	518598 (2592.99 MHz)	532998 (2664.99 MHz)	MPR Allowed per 3GPP	MPR [dB]
			Con	[dB]									
	1	1	24.38	24.91	24.69		0						
	1	67	24.43	24.88	24.67	0	0						
DFT-s-OFDM	1	131	24.76	24.95	24.78	1 [0						
$\pi/2$ BPSK	64	0	23.96	24.48	24.25	0-0.5	0.5						
<i>M</i> /2 DI 5K	64	35	24.42	24.91	24.65	0	0						
	64	69	24.01	24.48	24.24	0-0.5	0.5						
	128	0	24.17	24.53	24.46	0-0.0	0.5						
	1	1	24.26	24.97	25.06		0						
	1	67	24.55	24.90	24.84	0	0						
DFT-s-OFDM	1	131	24.70	24.94	25.02][0						
QPSK	64	0	23.41	23.93	23.80	0-1	1						
di on	64	35	24.56	24.95	24.81	0	0						
	64	69	23.58	24.04	23.67	0-1	1						
	128	0	23.54	23.85	23.79	0-1	1						
DFT-s-OFDM 16QAM	1	1	23.07	24.18	23.77	0-1	1						
CP-OFDM QPSK	1	1	22.60	23.33	23.49	0-1.5	1.5						

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				R Band n41 Hz Bandwidth									
			40 10		nnel								
Modulation	RB Size RB (RB Size	RB Size	RB Size	RB Size	RB Size	RB Offset	503202 (2516.01 MHz)	513468 (2567.34 MHz)	523734 (2618.67 MHz)	534000 (2670 MHz)	MPR Allowed per 3GPP	MPR Allowed per 3GPP
				[dB]	[dB]								
	1	1	24.80	25.37	25.22	25.30		0					
DFT-s-OFDM	1	53	24.89	25.43	25.28	25.15	0	0					
	1	104	24.77	25.26	25.14	25.28		0					
π/2 BPSK	50	0	24.54	24.95	24.60	24.89	0-0.5	0.5					
n/2 DI SK	50	28	24.73	25.28	25.02	25.17	0	0					
-	50	56	24.49	25.00	24.63	24.89	0-0.5	0.5					
	100	0	24.42	24.97	24.58	24.85	0-0.5	0.5					
	1	1	24.85	25.49	25.39	25.11		0					
	1	53	24.83	25.33	25.19	25.38	0	0					
	1	104	24.92	25.28	25.26	25.13		0					
DFT-s-OFDM QPSK	50	0	23.85	24.46	24.15	24.25	0-1	1					
	50	28	24.88	25.34	25.09	25.37	0	0					
	50	56	23.86	24.41	24.10	24.26	0-1	1					
	100	0	24.01	24.38	24.05	24.30	0-1	1					
DFT-s-OFDM 16QAM	1	1	23.74	24.20	24.46	24.50	0-1	1					
CP-OFDM QPSK	1	1	23.31	23.97	23.56	23.72	0-1.5	1.5					

Table 8-11NR n41 (2593.0MHz) Conducted Powers – 40MHz Bandwidth

Table 8-12NR n41 (2593.0MHz) Conducted Powers – 20MHz Bandwidth

				NR Band n 20 MHz Bandy	width				
		-		Channel					
Modulation RB Size	RB Size	RB Size RB Offset	501204 (2506.02 MHz)	509898 (2549.49 MHz)	518598 (2592.99 MHz)	527298 (2636.49 MHz)	535998 (2679.99 MHz)	MPR Allowed per 3GPP	MPR [dB]
			Conducted Power [dBm]					[dB]	
	1	1	24.72	24.81	25.12	24.86	25.01		0
	1	26	24.69	24.92	24.81	24.79	24.79	0	0
DFT-s-OFDM	1	49	24.84	24.82	25.07	24.94	24.82		0
$\pi/2$ BPSK	25	0	24.47	24.52	24.48	24.47	24.71	0-0.5	0.5
W2 DI SIC	25	13	24.77	24.87	25.28	24.76	25.03	0	0
	25	26	24.26	24.63	24.77	24.62	24.71	0-0.5	0.5
	50	0	24.36	24.67	24.54	24.43	24.53	0-0.5	0.5
	1	1	24.76	24.96	25.24	25.06	25.06		0
	1	26	24.73	25.12	25.16	25.09	25.18	0	0
DFT-s-OFDM	1	49	24.74	24.82	25.43	24.62	24.91		0
QPSK	25	0	23.69	23.95	23.96	23.71	24.11	0-1	1
	25	13	24.66	24.88	25.08	24.87	25.15	0	0
	25	26	23.72	23.86	23.97	23.81	24.05	0-1	1
	50	0	23.78	23.94	24.11	23.84	24.08	0-1	1
DFT-s-OFDM 16QAM	1	1	23.37	23.67	23.95	23.35	23.71	0-1	1
CP-OFDM QPSK	1	1	23.18	23.29	23.78	23.45	23.37	0-1.5	1.5

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XI. WIFI Target Powers (SISO/MIMO)

Г

			UZ.1	1b/g/n/a	ix(Ə	U) 2.4GF	1Z VVI	ri keau	cea A	werage i	KL L	ower ra	rgets	5		
		_	IEEE 802.11 (in dBm)													
	SISO								MIMO							
Mode	Band	Antenna 1 & Antenna 2						MIMO								
		b		g		n	n ax (SU) _{(CE}					n ax		ax (Sl	(SU)	
Nominal / Maximum Power		Nominal	Max	Nominal	Мах	Nominal Max		Nominal	Max	Nominal	Max	Nominal	Max	Nominal	Max	
2.4 GHz WIFI 2.45 GHz	2.45.045		15.0 16.0 15.0	45.0 40.0	15.0 16.0 15.0 1		16.0	18.0	19.0	18.0	19.0	17.0	18.0			
	2.40 GHZ	13.0	10.0	13.0	16.0	Ch 11: 13.5	14.5	Ch 11: 13.5	14.5	18.0	19.0	Ch. 11: 16.5	17.5	Ch. 1: 15.5 Ch. 11: 13.5	16.5 14.5	

Table 8-13 IEEE 802 11b/g/p/av/SUI) 2 4GHz WIEL Poducod Avorago PE Power Targets

Table 8-14 IEEE 802.11a/n/ac/ax(SU) 5GHz WIFI Reduced Average RF Power Targets¹

SISO								16									
Mode	Band			Ar		& Antenna 2							MI	MO			
		а	а		n			ax (SL	I)	a (CDD + ST	IBC)	n		ac		ax (SL	J)
	Maximum wer	Nominal	Max	Nominal	Max	Nominal	Max	Nominal	Max	Nominal	Max	Nominal	Max	Nominal	Max	Nominal	Max
	5200 MHz	12.0	13.0	12.0	13.0	12.0	13.0	12.0	13.0	15.0	16.0	15.0	16.0	15.0	16.0	15.0	16.0
5 GHz WIFI	5300 MHz	12.0	13.0	12.0	13.0	12.0	13.0	12.0	13.0	15.0	16.0	15.0	16.0	15.0	16.0	15.0	16.0
(20MHz BW)	5500 MHz	12.0	13.0	12.0	13.0	12.0	13.0	12.0	13.0	15.0	16.0	15.0	16.0	15.0	16.0	15.0	16.0
	5800 MHz	12.0	13.0	12.0	13.0	12.0	13.0	12.0	13.0	15.0	16.0	15.0	16.0	15.0	16.0	15.0	16.0
	5200 MHz			12.0	13.0	12.0	13.0	12.0	13.0			15.0	16.0	15.0	16.0	15.0	16.0
5 GHz WIFI (40MHz	5300 MHz			12.0	13.0	12.0	13.0	12.0	13.0			15.0	16.0	15.0	16.0	15.0 Ch. 62: 14.0	16.0 15.0
BW)	5500 MHz			12.0	13.0	12.0	13.0	12.0	13.0			15.0	16.0	15.0	16.0	15.0	16.0
	5800 MHz			12.0	13.0	12.0	13.0	12.0	13.0			15.0	16.0	15.0	16.0	15.0	16.0
	5200 MHz					12.0	13.0	12.0	13.0					15.0	16.0	15.0	16.0
5 GHz WIFI	5300 MHz					12.0	13.0	12.0	13.0					15.0	16.0	14.0	15.0
(80MHz BW)	5500 MHz					12.0	13.0	12.0	13.0					15.0	16.0	15.0	16.0
	5800 MHz					12.0	13.0	12.0	13.0					15.0	16.0	15.0	16.0

WIFI Target Powers for IEEE 802.11ax RU (SISO/MIMO) XII.

IEEE 802.11ax(RU) WIFI Reduced Average RF Power Targets ¹													
Tones			SISO (ANT	1/2) /in dBm		MIMO (ALL) /in dBm							
Tones		2.4GHz	5GHz/20MHz	5GHz/40MHz	5GHz/80MHz	2.4GHz	5GHz/20MHz	5GHz/40MHz	5GHz/80MHz				
26T	Maximum	14	11	11	11	14	11	11	11				
201	Nominal	13	10	10	10	13	10	10	10				
52T	Maximum	16	13	13	13	16	13	13	13				
	Nominal	15	12	12	12	15	12	12	12				
106T	Maximum	16	13	13	13	16	14	14	14				
	Nominal	15	12	12	12	15	13	13	13				
	Maximum	16	13	13	13	16	14	14	14				
242T	Maximum	ch. 11: 14.5				ch. 11: 14.5							
2421	Nominal	15	12	12	12	15	13	13	13				
	Nominai	ch. 11: 13.5				ch. 11: 13.5							
	Maximum			13	13			14	14				
484T	Waximum												
	Nominal			12	12			13	13				
	Nominai												
996T	Maximum				13				14				
9961	Nominal				12				13				

Table 8-15

¹ Note: This device utilizes independent power reduction mechanisms for the WIFI transmitter in all WIFI modes for held-to-ear scenarios.

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WIFI Target Powers for Operations with Simultaneous 2.4GHz and 5GHz XIII.

Table 8-16 IEEE 802.11b/g/n/ax(SU) 2.4GHz WIFI Reduced Average RF Power Targets¹ IEEE 802.11 (in dBm) SISO

Mode	Band				Antenna 1 a	& Antenna 2			МІМО							
		-	b		g n				ax (SU) g (CDD + STBC)		n		ax (SU)			
Nominal / Maximum Power		Nominal	Max	Nominal	Max	Nominal	Max	Nominal	Max	Nominal	Max	Nominal	Max	Nominal	Max	
2.4 GHz WIFI	2.45 GHz	12.0	13.0	12.0	13.0	12.0	13.0	12.0	13.0	15.0	16.0	15.0	16.0	15 Ch. 11: 13.5	16 Ch. 11: 14.5	

Table 8-17									
IEEE 802.11a/n/ac/ax(SU) 5GHz WIFI Reduced Average RF Power Targets ¹									
IEEE 802.11 (in dBm)									

		IEEE 802.11 (in dBm)															
				A.,	SI	SO & Antenna 2							МІ	NO			
Mode	Band	а		n		ac		ax (SL	ŋ	a (CDD + S1	IBC)	n		ac		ax (SL	Ŋ
	Maximum wer	Nominal	Max	Nominal	Max	Nominal	Max	Nominal	Max	Nominal	Max	Nominal	Max	Nominal	Max	Nominal	Max
	5200 MHz	12.0	13.0	12.0	13.0	12.0	13.0	12.0	13.0	15.0	16.0	15.0	16.0	15.0	16.0	15.0	16.0
5 GHz WIFI	5300 MHz	12.0	13.0	12.0	13.0	12.0	13.0	12.0	13.0	15.0	16.0	15.0	16.0	15.0	16.0	15.0	16.0
(20MHz BW)	5500 MHz	12.0	13.0	12.0	13.0	12.0	13.0	12.0	13.0	15.0	16.0	15.0	16.0	15.0	16.0	15.0	16.0
	5800 MHz	12.0	13.0	12.0	13.0	12.0	13.0	12.0	13.0	15.0	16.0	15.0	16.0	15.0	16.0	15.0	16.0
	5200 MHz			12.0	13.0	12.0	13.0	12.0	13.0			15.0	16.0	15.0	16.0	15.0	16.0
5 GHz WIFI (40MHz	5300 MHz			12.0	13.0	12.0	13.0	12.0	13.0			15.0	16.0	15.0	16.0	15.0 Ch. 62: 14.0	16.0 15.0
BW)	5500 MHz			12.0	13.0	12.0	13.0	12.0	13.0			15.0	16.0	15.0	16.0	15.0	16.0
	5800 MHz			12.0	13.0	12.0	13.0	12.0	13.0			15.0	16.0	15.0	16.0	15.0	16.0
	5200 MHz					12.0	13.0	12.0	13.0					15.0	16.0	15.0	16.0
5 GHz WIFI	5300 MHz					12.0	13.0	12.0	13.0					15.0	16.0	14.0	15.0
(80MHz BW)	5500 MHz					12.0	13.0	12.0	13.0					15.0	16.0	15.0	16.0
	5800 MHz					12.0	13.0	12.0	13.0					15.0	16.0	15.0	16.0

Table 8-18 IEEE 802.11ax(RU) WIFI Reduced Average RF Power Targets¹

Tones			SISO (ANT	1/2) /in dBm			MIMO (AL	.L) /in dBm	
Tones		2.4GHz	5GHz/20MHz	5GHz/40MHz	5GHz/80MHz	2.4GHz	5GHz/20MHz	5GHz/40MHz	5GHz/80MHz
26T	Maximum	13	11	11	11	13	11	11	11
201	Nominal	12	10	10	10	12	10	10	10
52T	Maximum	13	13	13	13	13	13	13	13
521	Nominal	12	12	12	12	12	12	12	12
106T	Maximum	13	13	13	13	13	13	13	13
	Nominal	12	12	12	12	12	12	12	12
	Maximum	13	13	13	13	13	13	13	13
242T	Nominal	12	12	12	12	12	12	12	12
484T	Maximum			13	13			13	13
	Nominal			12	12			12	12
996T	Maximum				13				13
9901	Nominal				12				12

¹ Note: This device utilizes independent power reduction mechanisms for the WIFI transmitter in all WIFI modes for held-to-ear scenarios.

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JUSTIFICATION OF HELD TO EAR MODES TESTED 9.

I. Analysis of RF Air Interface Technologies

An analysis was performed, following the guidance of §4.3 and §4.4 of the ANSI standard, of the RF air interface technologies being evaluated. The factors that will affect the RF interference potential were evaluated, and the worst-case operating modes were identified and used in the evaluation. A WD's interference potential is a function both of the WD's average near-field field strength and of the signal's audio-frequency amplitude modulation characteristics. Per §4.4, RF air interface technologies that have low power have been found to produce sufficiently low RF interference potential, so it is possible to exempt them from the product testing specified in Clause 5 of the ANSI standard. An RF air interface technology of a device is exempt from testing when its average antenna input power plus its MIF is ≤17dBm for all of its operating modes. RF air interface technologies exempted from testing in this manner are automatically assigned an M4 rating to be used in determining the overall rating for the WD.

The worst-case MIF plus the worst-case average antenna input power for all modes are investigated below to determine the testing requirements for this device.

Table 9-1

Max Power + MIF calculations for Low Power Exemptions											
Air Interface	Maximum Average Power (dBm)	Worst Case MIF (dB)	Total (Power + MIF, dB)	C63.19 Testing Required							
CDMA - Full Frame Rate	24.72	-19.66	5.06	No							
CDMA - 1/8 th Frame Rate	15.70 ¹	3.08	18.78	Yes							
CDMA - EvDO	24.58	-19.01	5.57	No							
GSM - GSM850	23.95 ¹	3.55	27.50	Yes							
GSM - GSM1900	20.68 ¹	3.55	24.23	Yes							
GSM - EDGE850	17.98 ¹	4.09	22.07	Yes ³							
GSM - EDGE1900	16.77 ¹	3.72	20.49	Yes ³							
UMTS - RMC	25.80	-22.05	3.75	No							
UMTS - AMR	25.80	-13.44	12.36	No							
UMTS - HSPA	24.80	-20.93	3.87	No							
LTE FDD	25.80	-9.35	16.45	No							
LTE TDD - Band 41 (PC3)	15.29 ¹	3.71	19.00	Yes							
NR FDD	25.50	-10.06	15.44	No							
NR TDD	19.47 ¹	1.49	20.96	Yes							
WIFI - 2.4GHz	19.00	-4.67	14.33	No							
WIFI - 5GHz	17.00	-10.30	6.70	No							
Simultaneous 2.4GHz and 5GHz WIFI Operations	19.02 ²	-5.05	13.97	No							

II. Individual Mode Evaluations

¹ Note: ANSI C63.19-2011 Sec. 4.4 Footnote 20 indicates the use of a long averaging time for measuring the antenna input power when using this method of exclusion. Therefore, the frame averaged power was calculated for these modes in this investigation.

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² Note: This value is calculated as the linear sum of the worst-case power for each band and antenna combination while in simultaneous 2.4GHz and 5GHz operation. This calculation is conservative and for use in this investigation only.

³ Note: EDGE data modes were considered but not tested as GSM voice modes were found to be the worst-case modes for the GSM air interface.

III. Low-Power Exemption Conclusions

Per ANSI C63.19-2011, RF Emissions testing for this device is required only for GSM and CDMA 1/8th Frame Rate voice modes as well as LTE TDD (Power Class 3) and NR TDD data modes. All other air interfaces are exempt.

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10. LTE TDD UPLINK-DOWNLINK CONFIGURATION

I. Uplink-Downlink Configuration Additional Testing

Additional testing was performed on each supported power class for LTE TDD to determine the worst-case Uplink-Downlink configuration for RFE testing.

Per 3GPP TS 36.211, the total frame length for each TDD radio frame of length $T_f = 307200 \cdot T_s = 10$ ms, where T_s is a number of time units equal to $1/(15000 \times 2048)$ seconds. Additionally, each radio frame consists of 10 subframes, each of length $30720 \cdot T_s = 1$ ms, and subframes can be designated as uplink (U), downlink (D), or special subframe (S), depending on the Uplink-Downlink configuration as indicated in Table 4.2-2 of 3GPP TS 36.211. In the transmission duty factor calculation, the special subframe configuration with the shortest UpPTS duration within the special subframe is used and will be applied for measurement. From 3GPP TS 36.211 Table 4.2-1, the shortest UpPTS is 2192 \cdot Ts which occurs in the normal cyclic prefix and special subframe configuration 4.

See table below outlining the calculated transmission duty cycles for each Uplink-Downlink configuration:

Uplink-downlink				Subframe number									
configuration	Switch-point periodicity	0	1	2	3	4	5	6	7	8	9	Duty Cycle (%)	
0	5 ms	D	S	U	U	U	D	S	U	U	U	61.4%	
1	5 ms	D	S	U	U	D	D	S	U	U	D	41.4%	
2	5 ms	D	S	U	D	D	D	S	U	D	D	21.4%	
3	10 ms	D	S	U	U	U	D	D	D	D	D	30.7%	
4	10 ms	D	S	U	U	D	D	D	D	D	D	20.7%	
5	10 ms	D	S	U	D	D	D	D	D	D	D	10.7%	
6	5 ms	D	S	U	U	U	D	S	U	U	D	51.4%	

 Table 10-1

 Uplink-Downlink Configurations for Type 2 Frame Structures

II. Power Class 3 Uplink-Downlink Configuration Additional Testing

LTE TDD was evaluated with the following radio configuration: channel 40620, 20MHz BW, 16QAM, 1RB, 0RB Offset. For Power Class 3, all configurations (0-6) are supported. The configuration which resulted in the worst-case emission was used for full testing. See Table 10-2 below for results. The configuration determined in the results below was used to measure the MIF values in Table 7-5.

			Ľ	TE T	DD	Pow	er Clas	s 3 UL·	-DL Co	nfigura	tion Re	sults			
Mode / Band	Bandwidth (MHz)	Channel	UL-DL Config.	Mod.	RB Size	RB Offset	Scan Center	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC Margin (dB)	Result	Excl Blocks per 5.5
E-Field Emissi	ions														
	20	40620	0	16QAM	1	0	Acoustic	10.26	20.22	-3.22	17.00	35.00	-18.00	M4	7,8,9
	20	40620	1	16QAM	1	0	Acoustic	9.04	19.12	-1.63	17.49	35.00	-17.51	M4	7,8,9
	20	40620	2	16QAM	1	0	Acoustic	6.59	16.37	1.48	17.85	35.00	-17.15	M4	7,8,9
LTE TDD / Band 41	20	40620	3	16QAM	1	0	Acoustic	8.07	18.14	-1.49	16.65	35.00	-18.35	M4	7,8,9
	20	40620	4	16QAM	1	0	Acoustic	6.44	16.18	0.67	16.85	35.00	-18.15	M4	7,8,9
	20	40620	5	16QAM	1	0	Acoustic	5.28	14.44	3.65	18.09	35.00	-16.91	M4	7,8,9
	20	40620	6	16QAM	1	0	Acoustic	10.11	20.10	-2.53	17.57	35.00	-17.43	M4	7,8,9

 Table 10-2

 LTE TDD Power Class 3 UL-DL Configuration Results

III. Conclusion

Per the results above, UL-DL Configuration 5 was used for LTE TDD Power Class 3 testing.

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11. OVERALL MEASUREMENT SUMMARY

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I. E-FIELD EMISSIONS:

			H	AC Dat	ta Sumr	nary for	E-field	- CDMA	1			
Mode	Channel	RC/SO	Scan Center	Conducted Power at BS (dBm)	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC Margin (dB)	Result	Excl Blocks per 5.5
E-Field Emissi	ons											
	1013	RC1/SO3	Acoustic	24.71	11.88	21.50	3.03	24.53	45.00	-20.47	M4	2,3,6
Cellular CDMA	384	RC1/SO3	Acoustic	24.73	12.88	22.20	3.08	25.28	45.00	-19.72	M4	2,3,6
	777	RC1/SO3	Acoustic	24.49	11.91	21.52	3.08	24.60	45.00	-20.40	M4	2,3,6

Table 11-1 HAC Data Summary for E-field – CDMA

 Table 11-2

 HAC Data Summary for E-field – GSM

Mode	Channel	Scan Center	Conducted Power at BS (dBm)	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC Margin (dB)	Result	Excl Blocks per 5.5
E-Field Emissi	ons										
	128	Acoustic	32.84	26.23	28.38	3.54	31.92	45.00	-13.08	M4	1,2,3
GSM850	190	Acoustic	33.14	29.39	29.36	3.55	32.91	45.00	-12.09	M4	1,2,3
	251	Acoustic	32.67	27.65	28.83	3.54	32.37	45.00	-12.63	M4	2,3,6
	512	Acoustic	29.82	12.65	22.04	3.55	25.59	35.00	-9.41	M4	7,8,9
GSM1900	661	Acoustic	29.56	10.88	20.73	3.55	24.28	35.00	-10.72	M4	7,8,9
	810	Acoustic	29.87	10.15	20.13	3.55	23.68	35.00	-11.32	M4	7,8,9

Table 11-3 HAC Data Summary for E-field – LTE TDD Band 41

Mode / Band	Bandwidth (MHz)	Channel	UL-DL Config.	Mod.	RB Size	RB Offset	Scan Center	Conducted Power at BS (dBm)	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC Margin (dB)	Result	Excl Blocks per 5.5
E-Field Emissi	ons															
	15	39750	5	16QAM	1	0	Acoustic	23.14	4.93	13.86	3.65	17.51	35.00	-17.49	M4	7,8,9
	15	40185	5	16QAM	1	0	Acoustic	23.20	4.66	13.37	3.50	16.87	35.00	-18.13	M4	7,8,9
LTE TDD / Band 41 PC3	15	40620	5	16QAM	1	0	Acoustic	23.06	5.05	14.06	3.70	17.76	35.00	-17.24	M4	7,8,9
	15	41055	5	16QAM	1	0	Acoustic	23.45	4.93	13.86	3.71	17.57	35.00	-17.43	M4	6,8,9
	15	41490	5	16QAM	1	0	Acoustic	23.20	5.02	14.02	3.59	17.61	35.00	-17.39	M4	6,8,9

 Table 11-4

 HAC Data Summary for E-field – NR n41

Mode / Band	Bandwidth (MHz)	Channel	Waveform	Mod.	RB Size	RB Offset	Scan Center		Time Avg. Field	Time Avg. Field	MIF (dB)	Audio Interference Level	FCC Limit (dBV/m)	FCC Margin (dB)	Result	Excl Blocks per 5.5
								(dBm)	(V/m)	[dB(V/m)]		[dB(V/m)]				
E-Field Emissi	ions															
	20	501204	DFT-s-OFDM	π/2-BPSK	50	0	Acoustic	24.36	31.12	29.86	1.49	31.35	35.00	-3.65	M3	2,3,6
	20	509898	DFT-s-OFDM	π/2-BPSK	50	0	Acoustic	24.67	30.42	29.66	1.45	31.11	35.00	-3.89	M3	2,3,6
NR TDD / n41	20	518598	DFT-s-OFDM	π/2-BPSK	50	0	Acoustic	24.54	28.30	29.04	1.48	30.52	35.00	-4.48	M3	2,3,6
	20	527298	DFT-s-OFDM	π/2-BPSK	50	0	Acoustic	24.43	28.52	29.10	1.45	30.55	35.00	-4.45	M3	2,3,6
	20	535998	DFT-s-OFDM	π/2-BPSK	50	0	Acoustic	24.53	27.15	28.68	1.46	30.14	35.00	-4.86	M3	2,3,6
	20	501204	DFT-s-OFDM	π/2-BPSK	50	0	T-Coil	24.36	18.62	25.40	1.49	26.89	35.00	-8.11	M4	3,6,9

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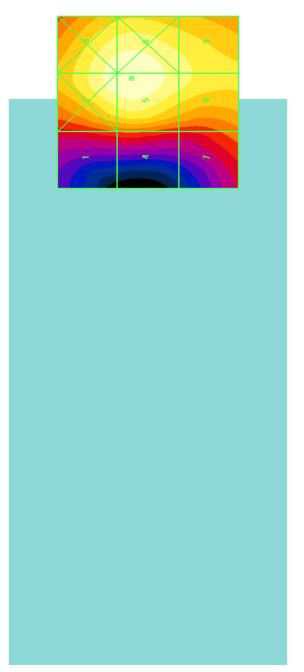


Figure 11-1 Sample E-field Scan Overlay (See Test Setup Photographs for actual WD overlay)

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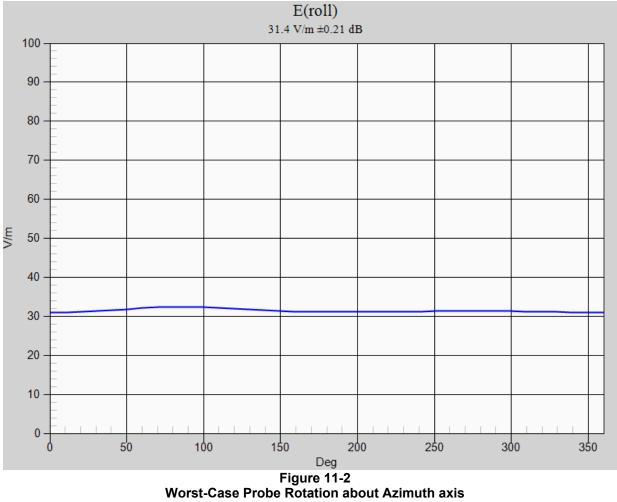
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S/N:	1280M

II. Worst-case Configuration Evaluation

	Peak Reading 360° Probe Rotation at Azimuth axis														
Mode	Bandwidth (MHz)	Channel	Waveform	Mod.	RB Size	RB Offset	Scan Center	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC Margin (dB)	Result	Excl Blocks per 5.5
Probe Rotatio	n at Worst-Cas	e													
NR TDD / n41	20	501204	DFT-s-OFDM	π/2-BPSK	50	0	Acoustic	32.43	30.22	1.49	31.71	35.00	-3.29	M3	2,3,6

Table 11-5



* Note: Locations of probe rotation (with and without exclusions) are shown in Figure 11-1 denoted by the green square markers.

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12. EQUIPMENT LIST

Table 12-1 Equipment List

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
Agilent	E4438C	ESG Vector Signal Generator	3/11/2019	Annual	3/11/2021	MY45090700
Agilent	N5182A	MXG Vector Signal Generator	7/10/2019	Annual	7/10/2020	MY47420800
Keysight Technologies	N9020A	MXA Signal Analyzer	12/19/2019	Annual	12/19/2020	MY48010233
Amplifier Research	15S1G6	Amplifier	N/A	CBT*	N/A	433978
Anritsu	MA24106A	USB Power Sensor	6/21/2019	Annual	6/21/2020	1244515
Anritsu	MA24106A	USB Power Sensor	7/8/2019	Annual	7/8/2020	1248508
Anritsu	MA2411B	Pulse Power Sensor	12/4/2019	Annual	12/4/2020	1126066
Anritsu	MA2411B	Pulse Power Sensor	8/8/2019	Annual	8/8/2020	1339008
Anritsu	ML2496A	Power Meter	11/6/2019	Annual	11/6/2020	1405003
Control Company	4040	Temperature / Humidity Monitor	10/9/2018	Biennial	10/9/2020	181647812
Mini-Circuits	NLP-1200+	Low Pass Filter DC to 1000 MHz	N/A	CBT*	N/A	N/A
Mini-Circuits	NLP-2950+	Low Pass Filter DC to 2700 MHz	N/A	CBT*	N/A	N/A
Mini-Circuits	BW-N20W5	Power Attenuator	N/A	CBT*	N/A	1226
Pasternack	PE2237-20	Bidirectional Coupler	N/A	CBT*	N/A	N/A
Rohde & Schwarz	CMW500	Radio Communication tester	8/14/2019	Annual	8/14/2020	140144
Rohde & Schwarz	CMW500	Wideband Radio Communication Tester	2/5/2020	Annual	2/5/2021	162125
Seekonk	NC-100	Torque Wrench (8" lb)	7/18/2019	Annual	7/18/2020	N/A
SPEAG	AIA	Audio Interference Analzyer	N/A	CBT*	N/A	1010
SPEAG	EF3DV3	Freespace E-field Probe	1/16/2019	Biennial	1/16/2021	4035
SPEAG	CD835V3	Freespace 835 MHz Dipole	2/19/2019	Biennial	2/19/2021	1003
SPEAG	CD1880V3	Freespace 1880 MHz Dipole	2/19/2019	Biennial	2/19/2021	1137
SPEAG	CD2600V3	Freespace 2600MHz Dipole	2/19/2019	Biennial	2/19/2021	1012
SPEAG	DAE4	Dasy Data Acquisition Electronics	2/12/2020	Annual	2/12/2021	665

Calibration traceable to the National Institute of Standards and Technology (NIST).

*Note: CBT (Calibrated Before Testing). Prior to testing, the measurement paths containing a cable, attenuator, coupler or filter were connected to a calibrated source (i.e. a signal generator) to determine the losses of the measurement path. The power meter offset was then adjusted to compensate for the measurement system losses. This level offset is stored within the power meter before measurements are made. This calibration verification procedure applies to the system verification and output power measurements. The calibrated reading is then taken directly from the power meter after compensation of the losses for all final power measurements.

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13. MEASUREMENT UNCERTAINTY

Table 13-1

Uncertainty Estimation Table

Wireless Communications Device Near-Field Measurement								
		Uncer	tainty Estima	ation				
Uncertainty Component	Data (dB)	Data Type	Prob. Dist.	Divisor	Ci (E)	Unc. (dB)	Notes/Comments	
Measurement System	-					-	-	
RF System Reflections	0.50	Tolerance	Ν	1.00	1	0.50	* Refl. < -20 dB	
Field Probe Calibration	0.21	Tolerance	Ν	1.00	1	0.21		
Field Probe Isotropy	0.01	Tolerance	Ν	1.00	1	0.01		
Field Probe Frequency Response	0.135	Tolerance	Ν	1.00	1	0.14		
Field Probe Linearity	0.013	Tolerance	Ν	1.00	1	0.01		
Modulation Interference Factor	0.20	Tolerance	R	1.73	1	0.12	Applicable for M-rating testing	
Boundary Effects	0.105	Accuracy	R	1.73	1	0.06	*	
Probe Positioning Accuracy	0.20	Accuracy	R	1.73	1	0.12	*	
Probe Positioner	0.050	Accuracy	R	1.73	1	0.03	*	
Extrapolation/Interpolation	0.045	Tolerance	R	1.73	1	0.03	*	
Resolution to 2mm error	0.21	Tolerance	Ν	1.00	1	0.21		
System Detection Limit	0.05	Tolerance	R	1.73	1	0.03	*	
Readout Electronics	0.015	Tolerance	Ν	1.00	1	0.02	*	
Integration Time	0.11	Tolerance	R	1.73	1	0.06	*	
Response Time	0.033	Tolerance	R	1.73	1	0.02	*	
Phantom Thickness	0.10	Tolerance	R	1.73	1	0.06	*	
System Repeatability (Field x 2=power)	0.17	Tolerance	Ν	1.00	1	0.17	*	
Test Sample Related								
Device Positioning Vertical	0.2	Tolerance	R	1.73	1	0.12	*	
Device Positioning Lateral	0.045	Tolerance	R	1.73	1	0.03	*	
Device Holder and Phantom	0.1	Tolerance	R	1.73	1	0.06	*	
Power Drift	0.21	Tolerance	R	1.73	1	0.12		
Combined Standard Uncertainty (k=1)						0.66	16.3%	
Expanded Uncertainty [95% confidence]					1.31	32.6%		
xpanded Uncertainty [95% confidence] on Field						0.66	16.3%	

Notes:

1. Test equipments are calibrated according to techniques outlined in NIS81, NIS3003 and NIST Tech Note 1297. All equipments have traceability according to NIST. Measurement Uncertainties are defined in further detail in NIS 81 and NIST Tech Note 1297 and UKAS M3003.

2. * Uncertainty specifications from Schmidt & Partner Engineering AG (not site specific)

Measurement uncertainty reflects the quality and accuracy of a measured result as compared to the true value. Such statements are generally required when stating results of measurements so that it is clear to the intended audience that the results may differ when reproduced by different facilities. Measurement results vary due to the measurement uncertainty of the instrumentation, measurement technique, and test engineer. Most uncertainties are calculated using the tolerances of the instrumentation used in the measurement, the measurement setup variability, and the technique used in performing the test. While not generally included, the variability of the equipment under test also figures into the overall measurements (so-called Type A uncertainty). This may mean that the Hearing Aid immunity tests may have to be repeated by taking down the test setup and resetting it up so that there are a statistically significant number of repeat measurements to identify the measurement uncertainty. By combining the repeat measurements to identify the measurement uncertainty. By combining the repeat measurements with that of the instrumentation chain using the technique contained in NIS 81 and NIS 3003, the overall measurement uncertainty was estimated.

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14. TEST DATA

See following Attached Pages for Test Data.

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DUT: CD835V3 - SN1003

Type: CD835V3 Serial: 1003

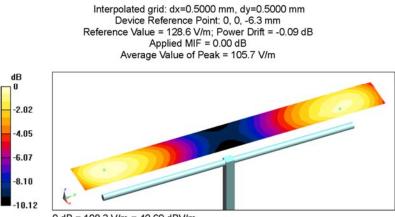
Communication System: CW; Frequency: 835 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 SN4035; Calibrated: 1/16/2019;
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn665; Calibrated: 2/12/2020
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (0);

835 MHz / 100mW HAC Dipole Validation at 15mm / Hearing Aid Compatibility Test (41x361x1):



0 dB = 108.3 V/m = 40.69 dBV/m

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DUT: CD1880V3 - SN1137

Type: CD1880V3 Serial: 1137

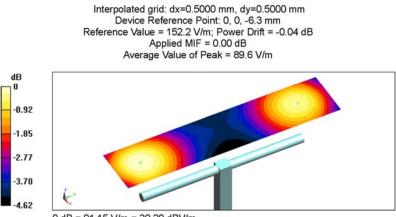
Communication System: CW; Frequency: 1880 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 SN4035; Calibrated: 1/16/2019;
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn665; Calibrated: 2/12/2020
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (0);

1880 MHz / 100mW HAC Dipole Validation at 15mm / Hearing Aid Compatibility Test (41x181x1):



0 dB = 91.15 V/m = 39.20 dBV/m

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DUT: CD2600V3 - SN1012

Type: CD2600V3 Serial: 1012

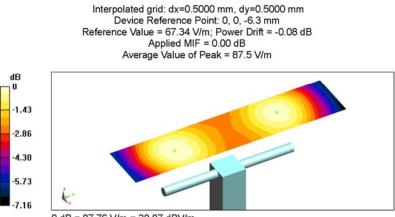
Communication System: CW; Frequency: 2600 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 SN4035; Calibrated: 1/16/2019;
- · Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn665; Calibrated: 2/12/2020
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (0);

2600 MHz / 100mW HAC Dipole Validation at 15mm / Hearing Aid Compatibility Test (41x181x1):



0 dB = 87.76 V/m = 38.87 dBV/m

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DUT: A3LSMN986W

Type: Portable Handset Serial: 1280M Backlight off Duty Cycle: 1:8

Communication System: CDMA; Frequency: 836.52 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

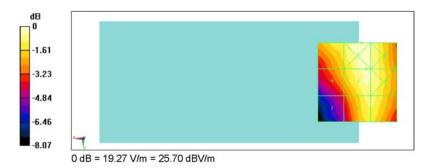
- Probe: EF3DV3 SN4035; Calibrated: 1/16/2019;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn665; Calibrated: 2/12/2020
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (0);

Cell. CDMA Mid Channel / Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 16.36 V/m; Power Drift = 0.15 dB Applied MIF = 3.08 dB RF audio interference level = 25.28 dBV/m **Emission category: M4**

MIF scaled E-field

Grid 1 M4	Grid 2 M4	Grid 3 M4
24.75 dBV/m	25.58 dBV/m	25.27 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
23.93 dBV/m	25.28 dBV/m	25.23 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
22.21 dBV/m	24.85 dBV/m	24.84 dBV/m



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DUT: A3LSMN986W

Type: Portable Handset Serial: 1280M Backlight off Duty Cycle: 1:8.3

Communication System: GSM; Frequency: 836.6 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

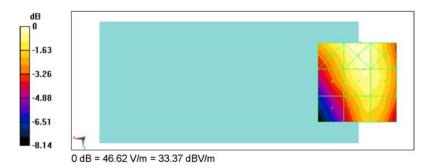
- Probe: EF3DV3 SN4035; Calibrated: 1/16/2019;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn665; Calibrated: 2/12/2020
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (0);

GSM850 Mid Channel / Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 38.82 V/m; Power Drift = 0.13 dB Applied MIF = 3.55 dB RF audio interference level = 32.91 dBV/m **Emission category: M4**

MIF scaled E-field

	Grid 8 M4 32.27 dBV/m	Grid 9 M4 32.21 dBV/m
		I
31 68 dBV/m	32.91 dBV/m	32 76 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
32.8 dBV/m	33.37 dBV/m	33.01 dBV/m
Grid 1 M4	Grid 2 M4	Grid 3 M4



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DUT: A3LSMN986W

Type: Portable Handset Serial: 1280M Backlight off Duty Cycle: 1:8.3

Communication System: GSM; Frequency: 1850.2 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 SN4035; Calibrated: 1/16/2019;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn665; Calibrated: 2/12/2020
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (0);

GSM1900 Low Channel / Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 5.379 V/m; Power Drift = 0.13 dB Applied MIF = 3.55 dB RF audio interference level = 25.59 dBV/m **Emission category: M4**

MIF scaled E-field

Grid 1 M4	Grid 2 M4	Grid 3 M4
25.55 dBV/m	25.59 dBV/m	24.55 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
20.8 dBV/m	21.24 dBV/m	21.23 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
26.44 dBV/m	26.64 dBV/m	25.77 dBV/m



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DUT: A3LSMN986W

Type: Portable Handset Serial: 1280M Backlight off Duty Cycle: 1:9.35

Communication System: LTE TDD41; Frequency: 2593 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

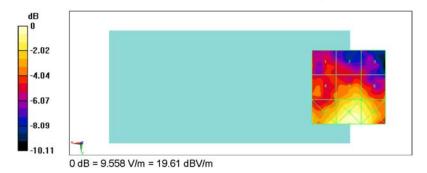
- Probe: EF3DV3 SN4035; Calibrated: 1/16/2019;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn665; Calibrated: 2/12/2020
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (0);

Power Class 3 TDD LTE Band 41, 15MHz BW, Mid Channel, UL-DL 5, 16QAM, 1RB, 0RB Offset Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 5.997 V/m; Power Drift = -0.17 dB Applied MIF = 3.70 dB RF audio interference level = 17.76 dBV/m **Emission category: M4**

MIF scaled E-field

Grid 1	M4	Grid 2 M4	Grid 3 M4
15.69	dBV/m	14.9 dBV/m	14.76 dBV/m
Grid 4	M4	Grid 5 M4	Grid 6 M4
15.86	dBV/m	17.76 dBV/m	17.52 dBV/m
Grid 7	M4	Grid 8 M4	Grid 9 M4
			18.96 dBV/m



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Date: 6/9/2020



DUT: A3LSMN986W

Type: Portable Handset Serial: 1280M Backlight off Duty Cycle: 1:4

Communication System: NR n41; Frequency: 2506 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 SN4035; Calibrated: 1/16/2019;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn665; Calibrated: 2/12/2020
- · Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (0);

NR TDD n41, 20MHz BW, Low Channel, DFT-s-OFDM, π/2-BPSK, 1RB, 1RB Offset Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 51.02 V/m; Power Drift = 0.05 dB Applied MIF = 1.49 dB RF audio interference level = 31.35 dBV/m Emission category: M3

MIF scaled E-field

Grid 1 M4	Grid 2 M3	Grid 3 M3
26.56 dBV/m	31.12 dBV/m	31.07 dBV/m
Grid 4 M4	Grid 5 M3	Grid 6 M3
26.74 dBV/m	31.35 dBV/m	31.29 dBV/m
Grid 7 M4	Grid 8 M3	Grid 9 M3
27.13 dBV/m	30.11 dBV/m	30.11 dBV/m



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15. CALIBRATION CERTIFICATES

The following pages include the probe calibration used to evaluate HAC for the DUT.

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Calibration Laboratory of

PC Test

Client

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 Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Certificate No: EF3-4035_Jan19

	CERTIFICATE		
Object	EF3DV3- SN:403	5	
Calibration procedure(s)	QA CAL-02.v9, Q/ Calibration proced evaluations in air	A CAL-25.v7 lure for E-field probes optimized f	or close near field
Calibration date:	January 16, 2019		2/11/2019
The measurements and the uno	certainties with confidence pro ucted in the closed laboratory	al standards, which realize the physical units bability are given on the following pages and facility: environment temperature $(22 \pm 3)^{\circ}$ C a	are part of the certificate.
Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration
Power meter NRP	SN: 104778	04-Apr-18 (No. 217-02672/02673)	Apr-19
ower sensor NRP-Z91	SN: 103244	04-Apr-18 (No. 217-02672)	Apr-19
a	SN: 103244 SN: 103245	04-Apr-18 (No. 217-02672) 04-Apr-18 (No. 217-02673)	Apr-19 Apr-19
ower sensor NRP-Z91		04-Apr-18 (No. 217-02672) 04-Apr-18 (No. 217-02673) 04-Apr-18 (No. 217-02682)	Apr-19
Power sensor NRP-Z91 Reference 20 dB Attenuator	SN: 103245	04-Apr-18 (No. 217-02673)	
Power sensor NRP-Z91 Reference 20 dB Attenuator DAE4	SN: 103245 SN: S5277 (20x)	04-Apr-18 (No. 217-02673) 04-Apr-18 (No. 217-02682)	Apr-19 Apr-19
Power sensor NRP-Z91 Reference 20 dB Attenuator DAE4 Reference Probe ER3DV6	SN: 103245 SN: S5277 (20x) SN: 789	04-Apr-18 (No. 217-02673) 04-Apr-18 (No. 217-02682) 14-Jan-19 (No. DAE4-789_Jan19)	Apr-19 Apr-19 Jan-20 Oct-19
Power sensor NRP-Z91 Reference 20 dB Attenuator DAE4 Reference Probe ER3DV6 Secondary Standards	SN: 103245 SN: S5277 (20x) SN: 789 SN: 2328	04-Apr-18 (No. 217-02673) 04-Apr-18 (No. 217-02682) 14-Jan-19 (No. DAE4-789_Jan19) 09-Oct-18 (No. ER3-2328_Oct18) Check Date (in house)	Apr-19 Apr-19 Jan-20 Oct-19 Scheduled Check
Power sensor NRP-Z91 Reference 20 dB Attenuator DAE4 Reference Probe ER3DV6 Secondary Standards Power meter E4419B	SN: 103245 SN: S5277 (20x) SN: 789 SN: 2328 ID	04-Apr-18 (No. 217-02673) 04-Apr-18 (No. 217-02682) 14-Jan-19 (No. DAE4-789_Jan19) 09-Oct-18 (No. ER3-2328_Oct18)	Apr-19 Apr-19 Jan-20 Oct-19 Scheduled Check In house check: Jun-20
Power sensor NRP-Z91 Reference 20 dB Attenuator DAE4 Reference Probe ER3DV6 Secondary Standards Power meter E4419B Power sensor E4412A	SN: 103245 SN: S5277 (20x) SN: 789 SN: 2328 ID SN: GB41293874	04-Apr-18 (No. 217-02673) 04-Apr-18 (No. 217-02682) 14-Jan-19 (No. DAE4-789_Jan19) 09-Oct-18 (No. ER3-2328_Oct18) Check Date (in house) 06-Apr-16 (in house check Jun-18)	Apr-19 Apr-19 Jan-20 Oct-19 Scheduled Check In house check: Jun-20 In house check: Jun-20
Power sensor NRP-Z91 Reference 20 dB Attenuator DAE4 Reference Probe ER3DV6 Secondary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A	SN: 103245 SN: S5277 (20x) SN: 789 SN: 2328 ID SN: GB41293874 SN: MY41498087	04-Apr-18 (No. 217-02673) 04-Apr-18 (No. 217-02682) 14-Jan-19 (No. DAE4-789_Jan19) 09-Oct-18 (No. ER3-2328_Oct18) Check Date (in house) 06-Apr-16 (in house check Jun-18) 06-Apr-16 (in house check Jun-18)	Apr-19 Apr-19 Jan-20 Oct-19 Scheduled Check In house check: Jun-20
Power sensor NRP-Z91 Reference 20 dB Attenuator DAE4 Reference Probe ER3DV6 Secondary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A RF generator HP 8648C	SN: 103245 SN: S5277 (20x) SN: 789 SN: 2328 ID SN: GB41293874 SN: MY41498087 SN: 000110210	04-Apr-18 (No. 217-02673) 04-Apr-18 (No. 217-02682) 14-Jan-19 (No. DAE4-789_Jan19) 09-Oct-18 (No. ER3-2328_Oct18) Check Date (in house) 06-Apr-16 (in house check Jun-18) 06-Apr-16 (in house check Jun-18)	Apr-19 Apr-19 Jan-20 Oct-19 Scheduled Check In house check: Jun-20 In house check: Jun-20 In house check: Jun-20
Power sensor NRP-Z91 Reference 20 dB Attenuator DAE4 Reference Probe ER3DV6 Secondary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A RF generator HP 8648C Network Analyzer E8358A	SN: 103245 SN: S5277 (20x) SN: 789 SN: 2328 ID SN: GB41293874 SN: MY41498087 SN: 000110210 SN: US3642U01700	04-Apr-18 (No. 217-02673) 04-Apr-18 (No. 217-02682) 14-Jan-19 (No. DAE4-789_Jan19) 09-Oct-18 (No. ER3-2328_Oct18) Check Date (in house) 06-Apr-16 (in house check Jun-18) 06-Apr-16 (in house check Jun-18) 06-Apr-16 (in house check Jun-18)	Apr-19 Apr-19 Jan-20 Oct-19 Scheduled Check In house check: Jun-20 In house check: Jun-20 In house check: Jun-20 In house check: Jun-20
Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator DAE4 Reference Probe ER3DV6 Secondary Standards Power sensor E4419B Power sensor E4419A Power sensor E4412A RF generator HP 8648C Network Analyzer E8358A Calibrated by:	SN: 103245 SN: S5277 (20x) SN: 789 SN: 2328 ID SN: GB41293874 SN: MY41498087 SN: 000110210 SN: US3642U01700 SN: US41080477 Name	04-Apr-18 (No. 217-02673) 04-Apr-18 (No. 217-02682) 14-Jan-19 (No. DAE4-789_Jan19) 09-Oct-18 (No. ER3-2328_Oct18) Check Date (in house) 06-Apr-16 (in house check Jun-18) 06-Apr-16 (in house check Jun-18) 06-Apr-16 (in house check Jun-18) 04-Aug-99 (in house check Jun-18) 31-Mar-14 (in house check Oct-18) Function	Apr-19 Apr-19 Jan-20 Oct-19 Scheduled Check In house check: Jun-20 In house check: Oct-19

Certificate No: EF3-4035_Jan19

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Glossary: NORMx,y,z DCP CF A, B, C, D En Ep	sensitivity in free space diode compression point crest factor (1/duty_cycle) of the RF signal modulation dependent linearization parameters incident E-field orientation normal to probe axis incident E-field orientation parallel to probe axis
Polarization φ	φ rotation around probe axis
Polarization 9	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1309-2005, " IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005 b)
- CTIA Test Plan for Hearing Aid Compatibility, Rev 3.1.1, May 2017

Methods Applied and Interpretation of Parameters:

- NORMx, y, z: Assessed for E-field polarization ϑ = 0 for XY sensors and ϑ = 90 for Z sensor (f \leq 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- NORM(f)x,y,z = NORMx,y,z * frequency_response (see Frequency Response Chart).
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z: A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. *VR* is the maximum calibration range expressed in RMS voltage across the diode.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

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DASY/EASY - Parameters of Probe: EF3DV3 - SN:4035

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm (μV/(V/m) ²)	0.90	0.74	1.20	± 10.1 %
DCP (mV) ^B	96.8	98.5	95.3	

Calibration results for Frequency Response (30 MHz – 6 GHz)

Frequency MHz	Target E-Field V/m	Measured E-field (En) V/m	Deviation E-normal in %	Measured E-field (Ep) V/m	Deviation E-normal in %	Unc (k=2) %
30	77.3	76.8	-0.6%	77.3	0.1%	± 5.1 %
100	77.3	78.2	1.2%	77.8	0.7%	± 5.1 %
450	77.1	78.2	1.5%	77.8	0.9%	± 5.1 %
600	77.1	77.8	0.9%	77.5	0.5%	± 5.1 %
750	77.3	77.7	0.5%	77.2	-0.1%	± 5.1 %
1800	140.3	136.9	-2.4%	137.2	-2.2%	± 5.1 %
2000	133.0	129.4	-2.8%	129.4	-2.7%	± 5.1 %
2200	124.8	121.5	-2.7%	122.7	-1.7%	± 5.1 %
2500	123.7	120.7	-2.4%	121.9	-1.5%	± 5.1 %
3000	78.8	74.8	-5.0%	76.1	-3.5%	± 5.1 %
3500	256.3	248.1	-3.2%	246.0	-4.0%	± 5.1 %
3700	249.7	239.2	-4.2%	239.0	-4.3%	<u>± 5.1 %</u>
5200	50.7	50.7	-0.1%	51.2	0.9%	± 5.1 %
5500	49.6	48.9	-1.5%	48.7	-1.9%	± 5.1 %
5800	48.9	49.1	0.4%	49.3	0.8%	± 5.1 %

Calibration Results for Modulation Response

UID	Communication System Name		A dB	B dBõV	С	D dB	VR mV	Max dev.	Unc ^E (k=2)
0	CW	X	0.0	0.0	1.0	0.00	141.5	+ 3.3 %	±4.7 %
		Y	0.0	0.0	1.0		125.6		
		Y	0.0	0.0	1.0		125.1		

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^B Numerical linearization parameter: uncertainty not required.
^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

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5/22/2020

EF3DV3 - SN:4035

DASY/EASY - Parameters of Probe: EF3DV3 - SN:4035

Sensor Frequency Model Parameters

	Sensor X	Sensor Y	Sensor Z
Frequency Corr. (LF)	0.28	0.21	5.68
Frequency Corr. (HF)	2.82	2.82	2.82

Other Probe Parameters

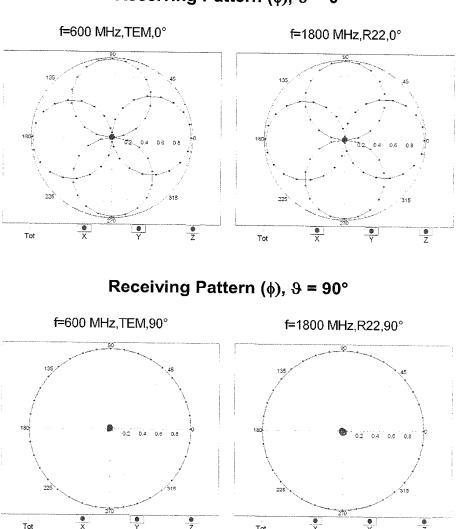
Sensor Arrangement	Rectangular
Connector Angle (°)	57.9
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	335 mm
Probe Body Diameter	12 mm
Tip Length	25 mm
Tip Diameter	4 mm
Probe Tip to Sensor X Calibration Point	1.5 mm
Probe Tip to Sensor Y Calibration Point	1.5 mm
Probe Tip to Sensor Z Calibration Point	1.5 mm

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January 16, 2019



Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$

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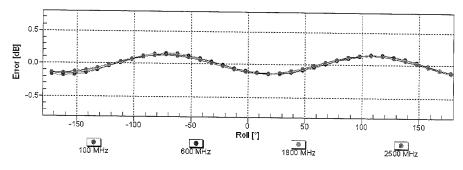
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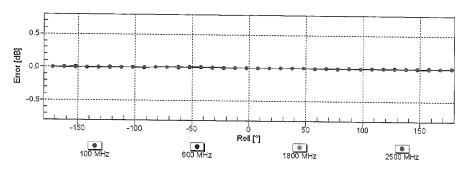
January 16, 2019



Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$



Receiving Pattern (ϕ), $\vartheta = 90^{\circ}$

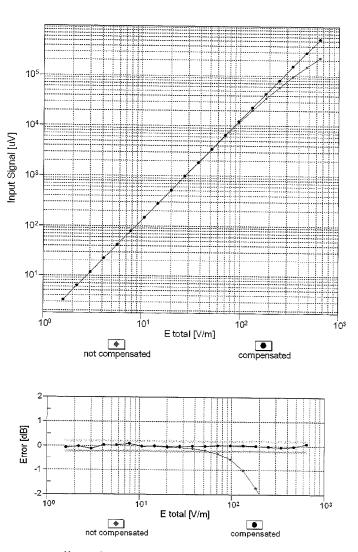


Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

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Dynamic Range f(E-field) (TEM cell, f = 900 MHz)

Uncertainty of Linearity Assessment: ± 0.6% (k=2)

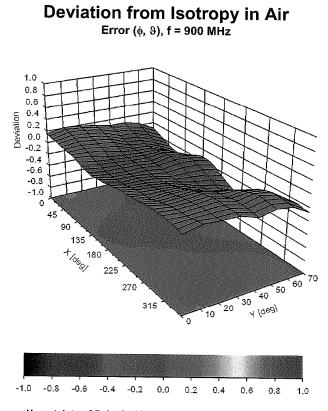
Certificate No: EF3-4035_Jan19

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EF3DV3 - SN:4035

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Uncertainty of Spherical Isotropy Assessment: \pm 2.6% (k=2)

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Client PC Test

Certificate No: CD835V3-1003_Feb19

Object	CD835V3 - SN:	1003	
Calibration procedure(s)	QA CAL-20.v7 Calibration Proc	edure for Validation Sources in ai	r /241 3/19/201
Calibration date:	February 19, 20	19	
The measurements and the unc	ertainties with confidence p ucted in the closed laborato	ional standards, which realize the physical un probability are given on the following pages an ry facility: environment temperature (22 \pm 3)°C	d are part of the certificate.
Primary Standards	ID #	Cal Date (Certificate No.)	
Power meter NRP	SN: 104778	04-Apr-18 (No. 217-02672/02673)	Scheduled Calibration
ower sensor NRP-Z91	SN: 103244	04-Apr-18 (No. 217-02672)	Apr-19
ower sensor NRP-Z91	SN: 103245	04-Apr-18 (No. 217-02072)	Apr-19
leference 20 dB Attenuator	SN: 5058 (20k)	04-Apr-18 (No. 217-02682)	Apr-19
ype-N mismatch combination	SN: 5047.2 / 06327	04-Apr-18 (No. 217-02082)	Apr-19
robe EF3DV3	SN: 4013	03-Jan-19 (No. EF3-4013_Jan19)	Apr-19
DAE4	SN: 781	09-Jan-19 (No. DAE4-781_Jan19)	Jan-20 Jan-20
econdary Standards	ID #	Check Date (in house)	Sebedulard Chaste
	SN: GB42420191	09-Oct-09 (in house check Oct-17)	Scheduled Check
ower meter Agilent 4419B	SN: US38485102	05-Jan-10 (in house check Oct-17)	In house check: Oct-20
•	1011.000040010/		In house check: Oct-20 In house check: Oct-20
ower sensor HP E4412A	SN: US37295597	09-Oct-09 (in house check Oct-17)	
ower sensor HP E4412A ower sensor HP 8482A		09-Oct-09 (in house check Oct-17) 27-Aug-12 (in house check Oct-17)	
ower sensor HP E4412A ower sensor HP 8482A IF generator R&S SMT-06	SN: US37295597	09-Oct-09 (in house check Oct-17) 27-Aug-12 (in house check Oct-17) 31-Mar-14 (in house check Oct-18)	In house check: Oct-20 In house check: Oct-19
ower meter Agilent 4419B ower sensor HP E4412A lower sensor HP 8482A IF generator R&S SMT-06 letwork Analyzer HP 8358A	SN: US37295597 SN: 832283/011	27-Aug-12 (in house check Oct-17)	In house check: Oct-20 In house check: Oct-19
ower sensor HP E4412A ower sensor HP 8482A IF generator R&S SMT-06	SN: US37295597 SN: 832283/011 SN: US41080477	27-Aug-12 (in house check Oct-17) 31-Mar-14 (in house check Oct-18)	In house check: Oct-20
ower sensor HP E4412A ower sensor HP 8482A F generator R&S SMT-06 etwork Analyzer HP 8358A	SN: US37295597 SN: 832283/011 SN: US41080477 Name	27-Aug-12 (In house check Oct-17) 31-Mar-14 (in house check Oct-18) Function	In house check: Oct-20 In house check: Oct-19
ower sensor HP E4412A ower sensor HP 8482A F generator R&S SMT-06 etwork Analyzer HP 8358A	SN: US37295597 SN: 832283/011 SN: US41080477 Name	27-Aug-12 (In house check Oct-17) 31-Mar-14 (in house check Oct-18) Function	In house check: Oct-20 In house check: Oct-19

Certificate No: CD835V3-1003_Feb19

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Approved by: PCTEST FCC ID: A3LSMN986W <u>a</u> HAC (RF EMISSIONS) TEST REPORT SAMSUNG Quality Manager DUT Type: Filename: Test Dates: Page 62 of 84 1M2004170066-17.A3L 06/08/2020 - 06/09/2020 Portable Handset © 2020 PCTEST **REV 3.5.M**

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Multilateral Agreement for the recognition of calibration certificates

References

[1]

ANSI-C63.19-2011

American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 15 mm above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
 figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
 is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
 directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.10.2
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	835 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 835 MHz

E-field 15 mm above dipole surface	condition	Interpolated maximum	
Maximum measured above high end	100 mW input power	105.2 V/m = 40.44 dBV/m	
Maximum measured above low end	100 mW input power	105.1 V/m = 40.43 dBV/m	
Averaged maximum above arm	100 mW input power	105.2 V/m ± 12.8 % (k=2)	

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

Frequency	Return Loss	Impedance	
800 MHz	17.6 dB	40.4 Ω - 7.2 jΩ	
835 MHz	25.8 dB	52.2 Ω + 4.7 jΩ	
880 MHz	16.9 dB	62.1 Ω - 10.5 jΩ	
900 MHz	16.9 dB	52.2 Ω - 14.6 jΩ	
945 MHz	21.6 dB	51.8 Ω + 8.3 jΩ	

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

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Impedance Measurement Plot

10,00 5.00 0.00 -5.00							1: 2: 3: 4: 5:	809.000000 MHz 835.000000 MHz 880.000000 MHz 900.000000 MHz 900.00000 MHz 945.000000 MHz	-17.586 dB 25.837 dB -16.937 dB -16.970 dB -21.641 dB
-10.00 -15.00 -20.00	[a								
-25.00 -30.00 -35.00 -40.00	Ch 1 Avg =			<u> </u>	Y	₩			
Ch1:	Start 335.000	MHz	 ··/······		l				
						*	1:	800.000000 MHz 27.676 pF	40.420 Ω -7.1883 Ω
			Ĥ				1: >2: 3: 4:	800.000000 MHz 27.676 pF 835.00000 MHz 902.00 pH 880.000000 MHz 17.263 pF 900.000000 MHz	40.420 Ω -7.1883 Ω 52.216 Ω 4.7323 Ω 62.123 Ω -10.477 Ω 52.237 Ω
							>2: 3:	800.00000 MHz 27.676 pF 835.00000 MHz 902.00 pH 880.00000 MHz 17.263 pF	40.420 Ω -7.1883 Ω 52.216 Ω 4.7323 Ω 62.123 Ω -10.477 Ω

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DASY5 E-field Result

Date: 19.02.2019

Test Laboratory: SPEAG Lab2

DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1003

 $\begin{array}{l} \mbox{Communication System: UID 0 - CW ; Frequency: 835 MHz } \\ \mbox{Medium parameters used: } \sigma = 0 \ S/m, \ \epsilon_r = 1; \ \rho = 0 \ kg/m^3 \\ \mbox{Phantom section: RF Section} \\ \mbox{Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)} \\ \end{array}$

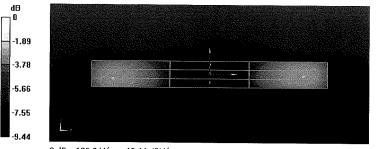
DASY52 Configuration:

- Probe: EF3DV3 SN4013; ConvF(1, 1, 1) @ 835 MHz; Calibrated: 03.01.2019
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 09.01.2019
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.10.2(1495); SEMCAD X 14.6.12(7450)

Dipole E-Field measurement @ 835MHz/E-Scan - 835MHz d=15mm/Hearing Aid Compatibility Test (41x361x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm Reference Value = 127.3 V/m; Power Drift = 0.04 dB Applied MIF = 0.00 dB RF audio interference level = 40.44 dBV/m Emission category: M3

> MIF scaled E-field Grid 1 M4 Grid 2 M3 Grid 3 M3 39.75 dBV/m 40.43 dBV/m 40.43 dBV/m Grid 4 **M4** Grid 5 M4 Grid 6 M4 35.35 dBV/m 35.75 dBV/m 35.73 dBV/m Grid 7 M3 Grid 8 M3 Grid 9 **M3** 40.15 dBV/m 40.44 dBV/m 40.36 dBV/m



0 dB = 105.2 V/m = 40.44 dBV/m

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Accreditation No.: SCS 0108

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Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates Client

PC Test

Certificate No: CD1880V3-1137_Feb19

Object	CD1880V3 - SN	: 1137		
Calibration procedure(s)	QA CAL-20,v7	- - - - -		JΛ
	Calibration Proc	edure for Validation Sources in a	ir	000
				3/19/2
Calibration date:	February 19, 20	19		
This calibration certificate docum	ents the traceability to not	ional standards, which realize the physical ur		
The measurements and the unce	ertainties with confidence r	ornal standards, which realize the physical un probability are given on the following pages a	hits of measurements (SI).	
	,	are showing pages a	in are part of the certificate.	
All calibrations have been conduc	cted in the closed laborato	ry facility: environment temperature (22 \pm 3)°	C and humidity < 70%	
		, , , , , , , , , , , , , , , , , , ,	o and harmany < 70%.	
Calibration Equipment used (M&	1			
Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration	
Power meter NRP	SN: 104778	04-Apr-18 (No. 217-02672/02673)	Apr-19	
ower sensor NRP-Z91	SN: 103244	04-Apr-18 (No. 217-02672)	Apr-19	
ower sensor NRP-Z91	SN: 103245	04-Apr-18 (No. 217-02673)	Apr-19	
eference 20 dB Attenuator	SN: 5058 (20k)	04-Apr-18 (No. 217-02682)	Apr-19	
ype-N mismatch combination	SN: 5047.2 / 06327	04-Apr-18 (No. 217-02683)	Apr-19	
Probe EF3DV3	SN: 4013	03-Jan-19 (No. EF3-4013_Jan19)	Jan-20	
DAE4	SN: 781	09-Jan-19 (No. DAE4-781_Jan19)	Jan-20	
Secondary Standards	ID #	Check Date (in house)	Scheduled Check	
ower meter Agilent 4419B	SN: GB42420191	09-Oct-09 (in house check Oct-17)		
ower sensor HP E4412A	SN: US38485102	05-Jan-10 (in house check Oct-17)	In house check: Oct-20	
ower sensor HP 8482A	SN: US37295597	09-Oct-09 (in house check Oct-17)	In house check: Oct-20	
IF generator R&S SMT-06	SN: 832283/011	27-Aug-12 (in house check Oct-17)	In house check: Oct-20	
etwork Analyzer HP 8358A	SN: US41080477	31-Mar-14 (in house check Oct-18)	In house check: Oct-20	
	1		In house check: Oct-19	
	Name	Function	Signature	
		Laboratory Technician		
alibrated by:	Claudio Leubler			
alibrated by:	Claudio Leubler			
alibrated by:	Claudio Leubler		LAL	
alibrated by: pproved by:	Claudio Leubler Katja Pokovic	Technical Manager	VAL -	
			LOL EUG	-

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Approved by: PCTEST FCC ID: A3LSMN986W (en) HAC (RF EMISSIONS) TEST REPORT SAMSUNG Quality Manager DUT Type: Filename: Test Dates: Page 67 of 84 1M2004170066-17.A3L 06/08/2020 - 06/09/2020 Portable Handset © 2020 PCTEST **REV 3.5.M**

^{5/22/2020}

Calibration Laboratory of Schmid & Partner Engineering AG

Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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 Schweizerischer Kalibrierdienst

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 Service suisse d'étalonnage

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 Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

References

[1] ANSI-C63.19-2011

American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 15 mm above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
 figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
 is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
 directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.10.2
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	1730 MHz ± 1 MHz 1880 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 1730 MHz

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	95.0 V/m = 39.55 dBV/m
Maximum measured above low end	100 mW input power	94.9 V/m = 39.55 dBV/m
Averaged maximum above arm	100 mW input power	95.0 V/m ± 12.8 % (k=2)

Maximum Field values at 1880 MHz

.

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	88.9 V/m = 38.98 dBV/m
Maximum measured above low end	100 mW input power	86.6 V/m = 38.75 dBV/m
Averaged maximum above arm	100 mW input power	87.8 V/m ± 12.8 % (k=2)

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Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

Nominal Frequencies

Frequency	Return Loss	Impedance
1730 MHz	22.5 dB	54.4 Ω + 6.5 jΩ
1880 MHz	21.1 dB	55.9 Ω + 7.2 jΩ
1900 MHz	21.0 dB	59.0 Ω + 3.6 jΩ
1950 MHz	27.3 dB	53.0 Ω - 3.3 jΩ
2000 MHz	20.3 dB	42.4 Ω + 4.8 jΩ

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

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Impedance Measurement Plot

7.00	Sw <u>e</u> ep	1	1			T	1.	1 200000 0:::	
2.00							1:	1.30000 GHz	-22.459 dB -21.146-dB
3.00							3:		-21.002.08
~							4	1.950000 GHz	-27.332 dB
-8.00		*					A 5'		-20.275.dB
-13.00		$+ \rightarrow +$				+			
18.00			~						
23.00		[\mathcal{I}		-ZA.	4			
			1	7	3	13			
28.00			<u> </u>	/		A	_		
33.00			V		4 V				
38.00									
43.00 Ch1Avg=	20								
Ch1: Start 1.38000	2012000 (CHINA 1000)							Stop	2.38000 GHz
							1:	1.730000 GHz	2.38000 GHz 54.408 Ω
							1: >2:	1.730000 GHz 601.12 pH 1.880000 GHz	54.408 Ω 6.5341 Ω 55.885 Ω
							>2:	1.730000 GHz 601.12 pH 1.880000 GHz 609.67 pH	54.408 Ω 6.5341 Ω 55.885 Ω 7.2016 Ω
			Â	$\langle \langle \rangle$	É			1.730000 GHz 601.12 pH 1.880000 GHz 609.67 pH 1.900000 GHz	54.408 Ω 6.5341 Ω 55.885 Ω 7.2016 Ω 59.017 Ω
			Â				>2:	1.730000 GHz 601.12 pH 1.880000 GHz 609.67 pH	54.408 Ω 6.5341 Ω 55.885 Ω 7.2016 Ω
			ĥ				>2: 3: 4:	1.730000 GHz 601.12 pH 1.880000 GHz 609.67 pH 1.900600 GHz 303.81 pH 1.950000 GHz 24.752 pF	54.408 Ω 6.5341 Ω 55.885 Ω 7.2016 Ω 59.017 Ω 3.6269 Ω 52.957 Ω -3.2975 Ω
			Ĥ				>2: 3:	1.730000 GHz 801.12 pH 1.880000 GHz 809.67 pH 1.300000 GHz 303.81 pH 1.950000 GHz 24.752 pF 2.00000 GHz	54.408 Ω 6.5341 Ω 55.885 Ω 7.2016 Ω 59.017 Ω 3.6269 Ω 52.957 Ω -3.2975 Ω 42.436 Ω
			A	X			>2: 3: 4:	1.730000 GHz 601.12 pH 1.880000 GHz 609.67 pH 1.900600 GHz 303.81 pH 1.950000 GHz 24.752 pF	54.408 Ω 6.5341 Ω 55.885 Ω 7.2016 Ω 59.017 Ω 3.6269 Ω 52.957 Ω -3.2975 Ω
			A				>2: 3: 4:	1.730000 GHz 801.12 pH 1.880000 GHz 809.67 pH 1.300000 GHz 303.81 pH 1.950000 GHz 24.752 pF 2.00000 GHz	54.408 Ω 6.5341 Ω 55.885 Ω 7.2016 Ω 59.017 Ω 3.6269 Ω 52.957 Ω -3.2975 Ω 42.436 Ω
							>2: 3: 4:	1.730000 GHz 801.12 pH 1.880000 GHz 809.67 pH 1.300000 GHz 303.81 pH 1.950000 GHz 24.752 pF 2.00000 GHz	54.408 Ω 6.5341 Ω 55.885 Ω 7.2016 Ω 59.017 Ω 3.6269 Ω 52.957 Ω -3.2975 Ω 42.436 Ω
							>2: 3: 4:	1.730000 GHz 801.12 pH 1.880000 GHz 809.67 pH 1.300000 GHz 303.81 pH 1.950000 GHz 24.752 pF 2.00000 GHz	54.408 Ω 6.5341 Ω 55.885 Ω 7.2016 Ω 59.017 Ω 3.6269 Ω 52.957 Ω -3.2975 Ω 42.436 Ω
Ch 1 Avg = Ch 1: Start 1.38000 (20		<i>(</i>				>2: 3: 4:	1.730000 GHz 801.12 pH 1.880000 GHz 809.67 pH 1.300000 GHz 303.81 pH 1.950000 GHz 24.752 pF 2.00000 GHz	54.408 Ω 6.5341 Ω 55.885 Ω 7.2016 Ω 59.017 Ω 3.6269 Ω 52.957 Ω -3.2975 Ω 42.436 Ω

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5/22/2020

DASY5 E-field Result

Date: 19.02.2019

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1137

Communication System: UID 0 - CW ; Frequency: 1880 MHz, Frequency: 1730 MHz Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: EF3DV3 SN4013; ConvF(1, 1, 1) @ 1880 MHz, ConvF(1, 1, 1) @ 1730 MHz; Calibrated: 03.01.2019
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 09.01.2019
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.10.2(1495); SEMCAD X 14.6.12(7450)

Dipole E-Field measurement @ 1880MHz/E-Scan - 1880MHz d=15mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm Reference Value = 151.5 V/m; Power Drift = 0.02 dB Applied MIF = 0.00 dB RF audio interference level = 38.98 dBV/m Emission category: M2

MIF scaled E-field

Grid 7 M2 38.31 dBV/m		Grid 9 M2 38.73 dBV/m
35.71 dBV/m		
-	38.98 dBV/m Grid 5 M2	
Grid 1 M2	Grid 2 M2	Grid 3 M2

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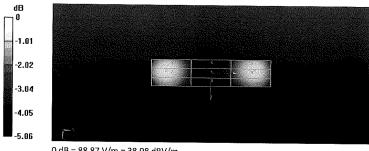
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Dipole E-Field measurement @ 1880MHz/E-Scan - 1730MHz d=15mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 165.0 V/m; Power Drift = 0.03 dB Applied MIF = 0.00 dB RF audio interference level = 39.55 dBV/m Emission category: M2

MIF scaled E-field

Grid 1 M2	Grid 2 M2	Grid 3 M2
39.09 dBV/m	39.55 dBV/m	39.51 dBV/m
Grid 4 M2	Grid 5 M2	Grid 6 M2
36.57 dBV/m	36.95 dBV/m	36.95 dBV/m
Grid 7 M2	Grid 8 M2	Grid 9 M2
20.05.101/	20 55 401/	39.53 dBV/m



0 dB = 88.87 V/m = 38.98 dBV/m

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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



S C S S

Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Client PC Test

Certificate No: CD2600V3-1012_Feb19

Object	CD2600V3 - SN: 1012					
Calibration procedure(s)	QA CAL-20.v7 Calibration Proc	edure for Validation Sources in a	ir /0,4 3/19/2			
Calibration date:	February 19, 20	19				
This calibration certificate docur	nents the traceability to nat	ional standards, which realize the physical un	its of measurements (SI).			
the measurements and the unc	ertainties with confidence p	probability are given on the following pages ar	nd are part of the certificate.			
All calibrations have been condu	icted in the closed laborate	ry facility: environment temperature (22 \pm 3)°	C and humidity < 70%.			
Calibration Equipment used (M8	TE critical for calibration)					
Primary Standards	ID # "	Cal Date (Certificate No.)	Scheduled Calibration			
ower meter NRP	SN: 104778	04-Apr-18 (No. 217-02672/02673)	Apr-19			
ower sensor NRP-Z91	SN: 103244	04-Apr-18 (No. 217-02672)	Apr-19			
ower sensor NRP-Z91	SN: 103245	04-Apr-18 (No. 217-02673)	Apr-19			
eference 20 dB Attenuator	SN: 5058 (20k)	04-Apr-18 (No. 217-02682)	Apr-19			
pe-N mismatch combination	SN: 5047.2 / 06327	04-Apr-18 (No. 217-02683)	Apr-19			
robe EF3DV3	SN: 4013	03-Jan-19 (No. EF3-4013 Jan19)	Jan-20			
AE4	SN: 781	09-Jan-19 (No. DAE4-781_Jan19)	Jan-20			
econdary Standards	ID#	Check Date (in house)	Scheduled Check			
ower meter Agilent 4419B	SN: GB42420191	09-Oct-09 (in house check Oct-17)	In house check: Oct-20			
ower sensor HP E4412A	SN: US38485102	05-Jan-10 (in house check Oct-17)	In house check: Oct-20			
ower sensor HP 8482A	SN: US37295597	09-Oct-09 (in house check Oct-17)	In house check; Oct-20			
F generator R&S SMT-06	SN: 832283/011	27-Aug-12 (in house check Oct-17)	In house check: Oct-20			
etwork Analyzer HP 8358A	SN: US41080477	31-Mar-14 (in house check Oct-18)	In house check: Oct-19			
	Name	Function	Signature			
alibrated by:	Claudio Leubler	Laboratory Technician	URA			
		Technical Manager	MJ Jun			
pproved by:	Katja Pokovic	, contribut (Manager	XV/X			
pproved by:	Katja Pokovic	, connect manager	telt			

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References

[1] ANSI-C63.19-2011

American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 15 mm above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
 figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
 is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
 directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.10.2
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	2600 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 2600 MHz

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	85.6 V/m = 38.65 dBV/m
Maximum measured above low end	100 mW input power	84.7 V/m = 38.56 dBV/m
Averaged maximum above arm	100 mW input power	85.2 V/m ± 12.8 % (k=2)

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

Frequency	Return Loss Imped	
2450 MHz	20.5 dB	42.7 Ω - 4.8 jΩ
2550 MHz	32.1 dB	48.9 Ω + 2.2 jΩ
2600 MHz	39.6 dB	50.3 Ω + 1.0 jΩ
2650 MHz	30.4 dB	53.0 Ω + 0.9 jΩ
2750 MHz	20.9 dB	48.9 Ω - 8.9 ϳΩ

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

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Impedance Measurement Plot

7.00	18611						1	1:	2.450000 GHz	1 00 404 45
2.00								- 2:	2.400000 GHz 2.550000 GHz	-20.461 df
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			~						250000.GHz	-~20.889.dF
-13.00 -18.00								- /~		
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					2	1/4				
38.00			<u> </u>			₩				
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Un1:	Start 2,10000 GH					.			Stop	3.10000 GHz
Un1:	Start 2.10000 GH					L		1.		
Un1:	Start 2.10000 GH							1:	2.450000 GHz	42.652 Ω
	Start 2.10000 GH						X	1:		42.652 Ω -4.8399 Ω
Un1:	Start 2.10000 GH							2:	2.450000 GHz 13.422 pF 2.550000 GHz 137.02 pH	42.652 Ω
Un1:	Start 2.10000 GH								2.450000 GHz 13.422 pF 2.550000 GHz 137.02 pH 2.600000 GHz	42.652 Ω -4.8399 Ω 48.871 Ω 2.1953 Ω 50.278 Ω
Un1:	Start 2.10000 GH			6				2: >3:	2.450000 GHz 13.422 pF 2.550000 GHz 137.02 pH 2.600000 GHz 61.734 pH	42,652 Ω -4,8399 Ω 48,871 Ω 2,1953 Ω 50,278 Ω 1,0085 Ω
	Start 2.10000 GH			6	A			2:	2.450000 GHz 13.422 pF 2.550000 GHz 137.02 pH 2.600000 GHz 61.734 pH 2.650000 GHz	42.652 Ω -4.8399 Ω 48.871 Ω 2.1953 Ω 50.278 Ω 1.0085 Ω 52.971 Ω
	Start 2.10000 GH			6				2: >3:	2.450000 GHz 13.422 pF 2.550000 GHz 137.02 pH 2.600000 GHz 61.734 pH 2.650000 GHz 53.679 pH	42.652 Ω -4.8399 Ω 48.871 Ω 2.1953 Ω 50.278 Ω 1.0085 Ω 52.971 Ω 893.78 mΩ
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	Start 2.10000 GH			6				2: >3: 4:	2.450000 GHz 13.422 pF 2.550000 GHz 137.02 pH 2.600000 GHz 61.734 pH 2.650000 GHz 53.679 pH 2.750000 GHz	42,652 Ω -4,8399 Ω 48,871 Ω 2,1953 Ω 50,278 Ω 1,0085 Ω
	Start 2.10000 GH			6				2: >3: 4:	2.450000 GHz 13.422 pF 2.550000 GHz 137.02 pH 2.600000 GHz 61.734 pH 2.650000 GHz 53.679 pH 2.750000 GHz	42.652 Ω -4.8399 Ω 48.871 Ω 2.1953 Ω 50.278 Ω 1.0085 Ω 52.971 Ω 893.78 mΩ 48.912 Ω
	Start 2.10000 GH			A				2: >3: 4:	2.450000 GHz 13.422 pF 2.550000 GHz 137.02 pH 2.600000 GHz 61.734 pH 2.650000 GHz 53.679 pH 2.750000 GHz	42.652 Ω -4.8399 Ω 48.871 Ω 2.1953 Ω 50.278 Ω 1.0085 Ω 52.971 Ω 893.78 mΩ 48.912 Ω
		2		Í				2: >3: 4:	2.450000 GHz 13.422 pF 2.550000 GHz 137.02 pH 2.600000 GHz 61.734 pH 2.650000 GHz 53.679 pH 2.750000 GHz	42.652 Ω -4.8399 Ω 48.871 Ω 2.1953 Ω 50.278 Ω 1.0085 Ω 52.971 Ω 893.78 mΩ 48.912 Ω
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DASY5 E-field Result

Date: 19.02.2019

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 2600 MHz; Type: CD2600V3; Serial: CD2600V3 - SN: 1012

 $\begin{array}{l} \mbox{Communication System: UID 0 - CW ; Frequency: 2600 MHz \\ \mbox{Medium parameters used: } \sigma = 0 \mbox{ S/m, } \epsilon_r = 1; \mbox{ } \rho = 0 \mbox{ kg/m}^3 \\ \mbox{Phantom section: } RF \mbox{ Section } \\ \mbox{Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)} \\ \end{array}$

DASY52 Configuration:

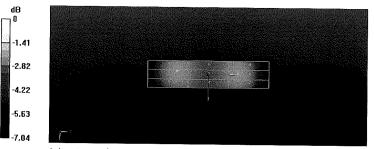
- Probe: EF3DV3 SN4013; ConvF(1, 1, 1) @ 2600 MHz; Calibrated: 03.01.2019
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 09.01.2019
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.10.2(1495); SEMCAD X 14.6.12(7450)

Dipole E-Field measurement @ 2600MHz - with/E-Scan - 2600MHz d=15mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm Reference Value = 62.82 V/m; Power Drift = -0.01 dB Applied MIF = 0.00 dB RF audio interference level = 38.65 dBV/m Emission category: M2

MIF scaled E-field

Grid 1 M2	Grid 2 M2	Grid 3 M2
38.09 dBV/m	38.56 dBV/m	38.54 dBV/m
Grid 4 M2	Grid 5 M2	Grid 6 M2
37.82 dBV/m	38.06 dBV/m	38.02 dBV/m
Grid 7 M2	Grid 8 M2	Grid 9 M2
38.36 dBV/m	38.65 dBV/m	38.56 dBV/m



0 dB = 85.60 V/m = 38.65 dBV/m

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16. CONCLUSION

The measurements indicate that the wireless communications device complies with the HAC limits specified in accordance with the ANSI C63.19 Standard and FCC WT Docket No. 01-309 RM-8658. Precise laboratory measures were taken to assure repeatability of the tests. The tested device complies with the requirements in respect to all parameters specific to the test. The test results and statements relate only to the item(s) tested.

Please note that the M-rating for this equipment only represents the field interference possible against a hypothetical and typical hearing aid. The measurement system and techniques presented in this evaluation are proposed in the ANSI standard as a means of best approximating wireless device compatibility with a hearing-aid. The literature is under continual re-construction.

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